

QUANTAX WDS

In-situ light element determination using WDS for SEM

Bruker Nano Analytics, Berlin, Germany

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Presenters

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Outline

01 Challenges with light element analysis

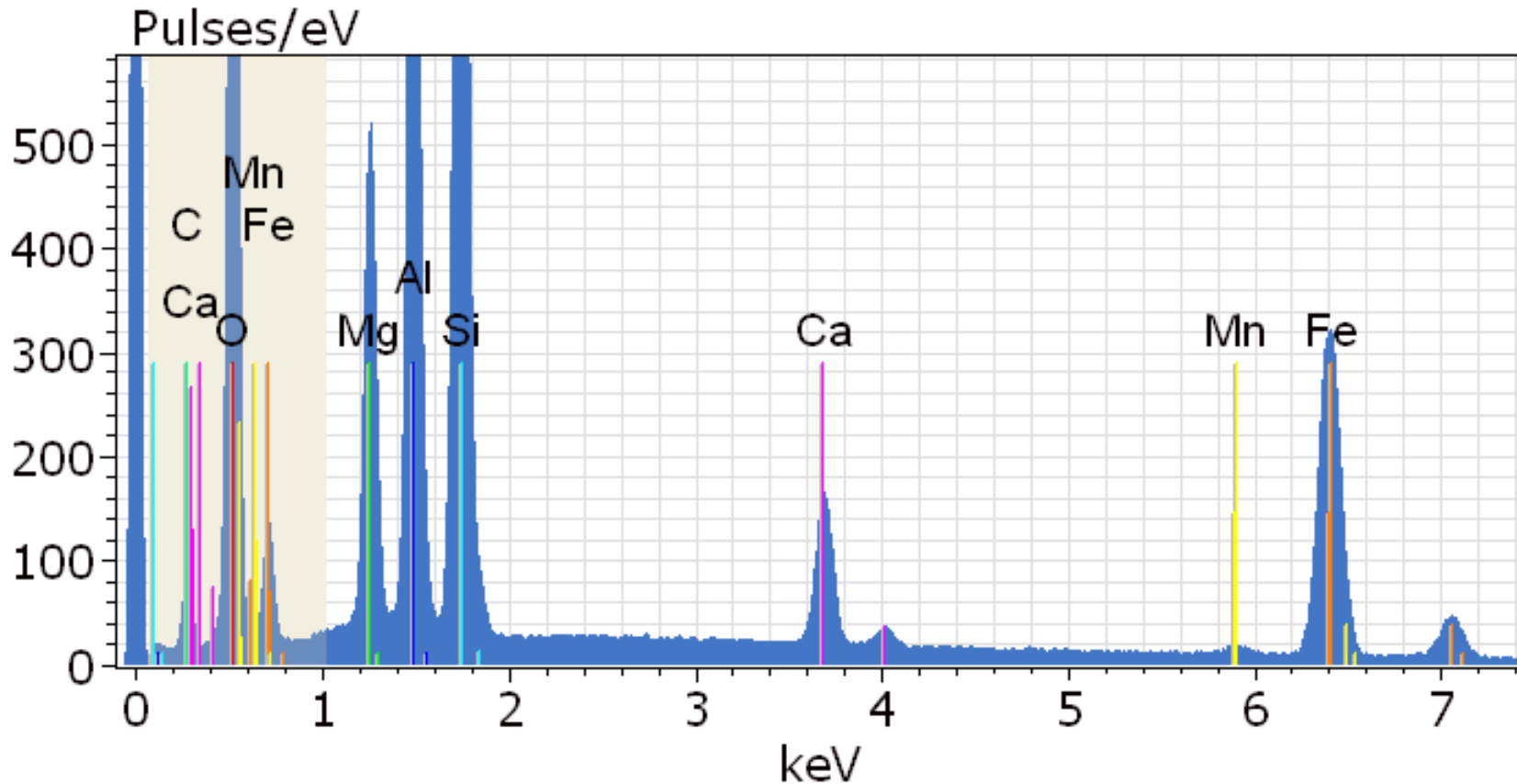
02 QUANTAX WDS solution for SEM

03 Applications examples on Be, B, C, N and O
(incl. workflows)

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Challenges with light element analysis

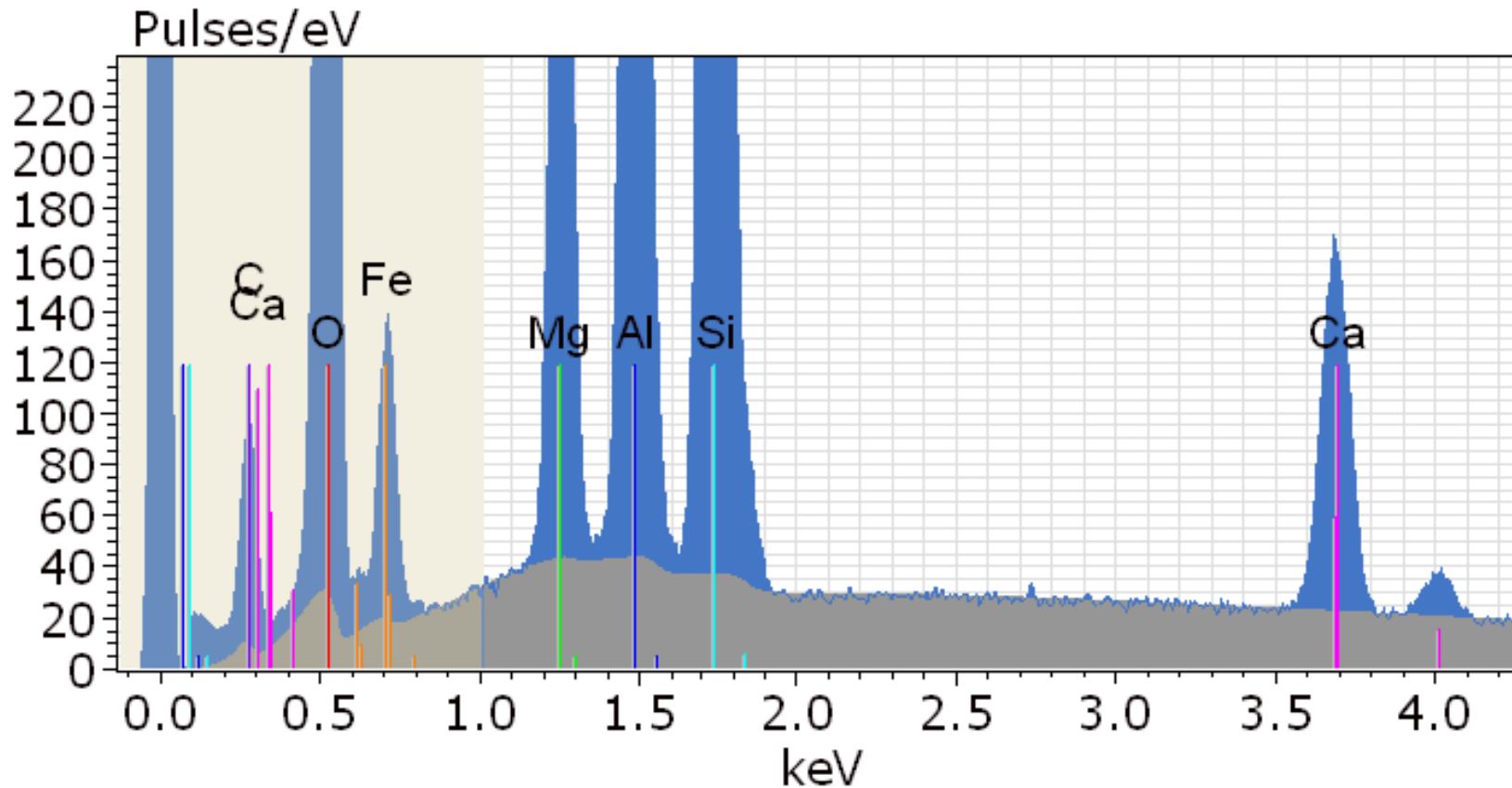
Definition low energy range and light elements



Almandine
 Garnet:
 $\text{Fe}_3\text{Al}_2\text{Si}_3\text{O}_{12}$
 (+ Mg, Ca,...)
 HV=20 kV

- Low energy range: $E < 1\text{keV}$
- Light elements $Z < 11$: (Li, 54eV), Be (108eV), B, C, N, O, F (676eV)

Low energy range

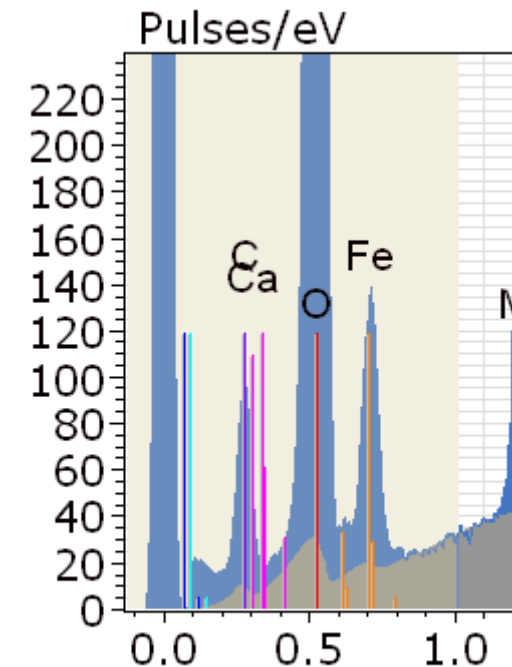


Almandine
Garnet:
 $\text{Fe}_3\text{Al}_2\text{Si}_3\text{O}_{12}$
(+ Mg, Ca,...)
HV=20 kV

- For $E \geq 1\text{keV}$ the background is clearly defined

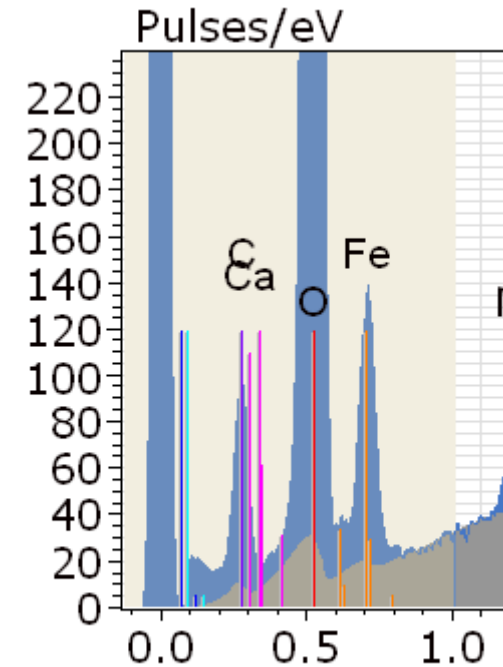
Low energy range

- for $E \geq 1\text{keV}$ the background is clearly defined
- for $E < 1\text{keV}$ the background calculation is difficult:
 - BG is lower \rightarrow errors due to statistical noise
 - high absorption edges, variations in TOA influence low energy BG shape
- high line density \rightarrow overlap likely, determination of peak free areas difficult, especially for EDS



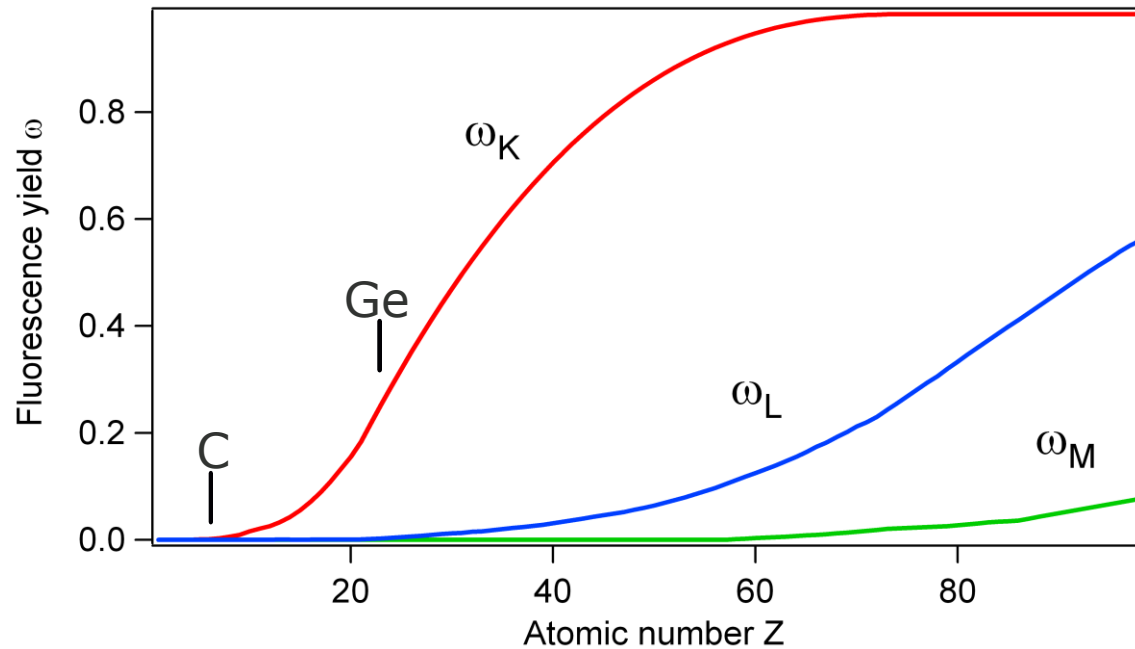
Parameters which are important for light element quantification

- Fluorescence yield of element
- Quantum efficiency ε of detector at the line energy
- Absorption of line



Fluorescence yield and quantum efficiency

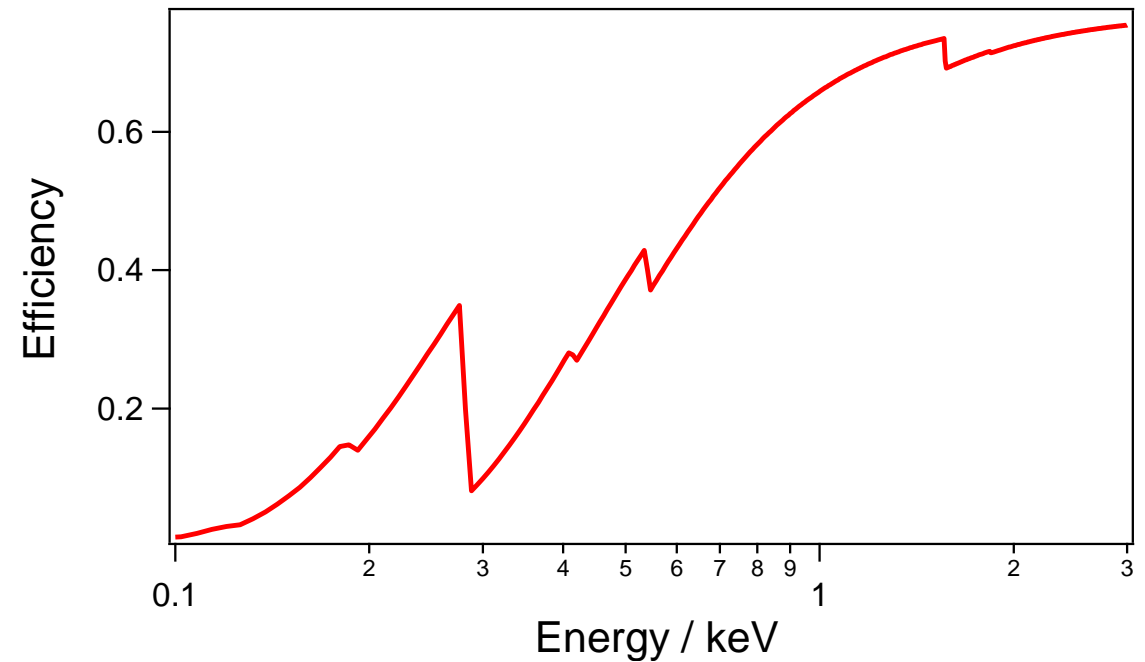
- Fluorescence yield (ω):



Fluorescence yield (ω):

$$\omega_K = \frac{\#K \text{ photons produced}}{\#K - \text{shell ionizations}}$$

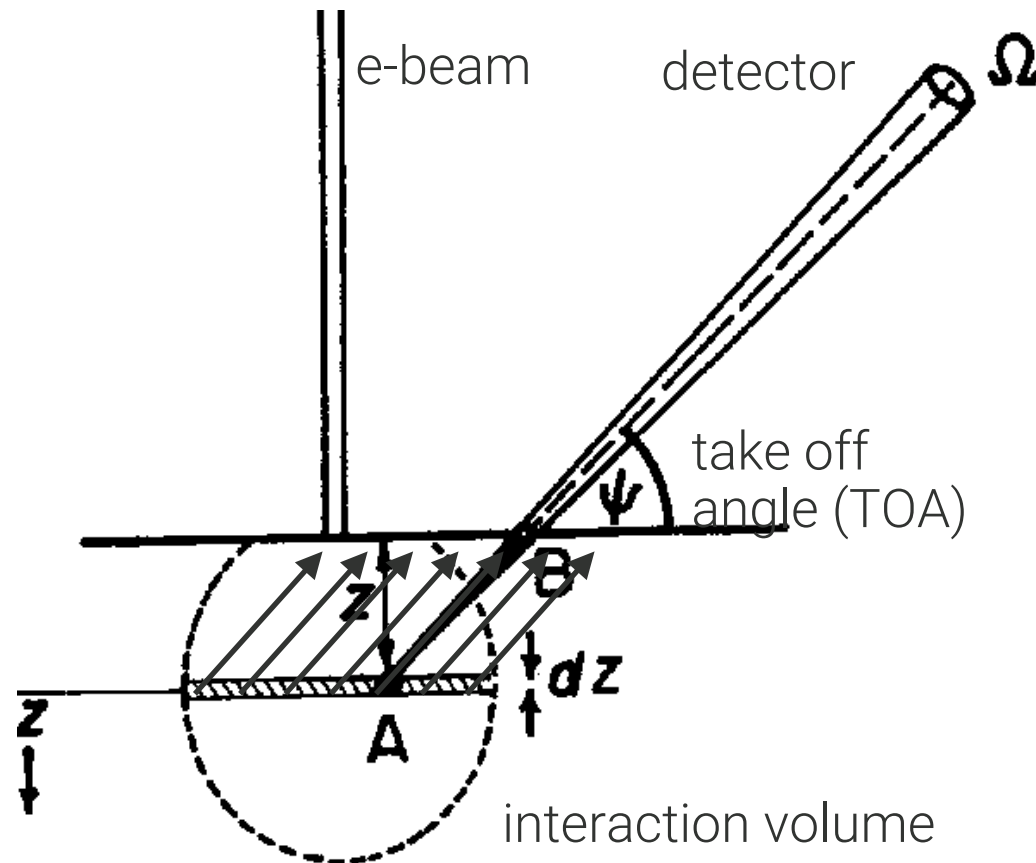
- Quantum efficiency of EDS



$$\varepsilon = \frac{\# \text{ detected x-rays}}{\# \text{ incoming x-rays}}$$

Absorption effect

- X-rays which are excited at a certain depth z will be partly absorbed on their way to sample surface



$$f_A = \frac{\text{\# x-rays leaving sample}}{\text{\# generated x-rays}}$$

$f_A = 1$: no absorption

$f_A = 0.1$: 90% absorption

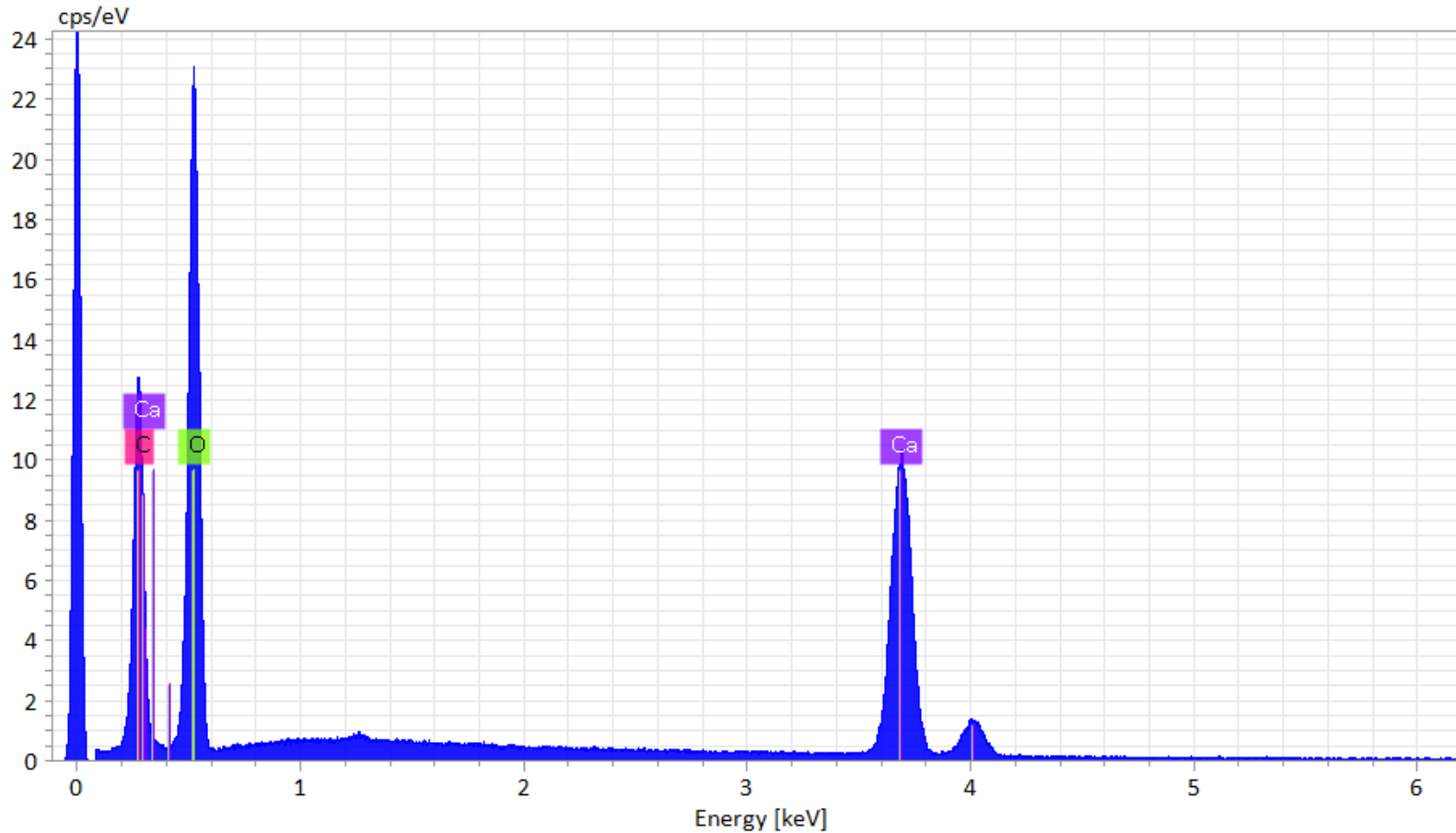
f_A depends on path length

→ TOA

→ HV (mean depth)

Absorption effect of Ca, C and O in CaCO₃

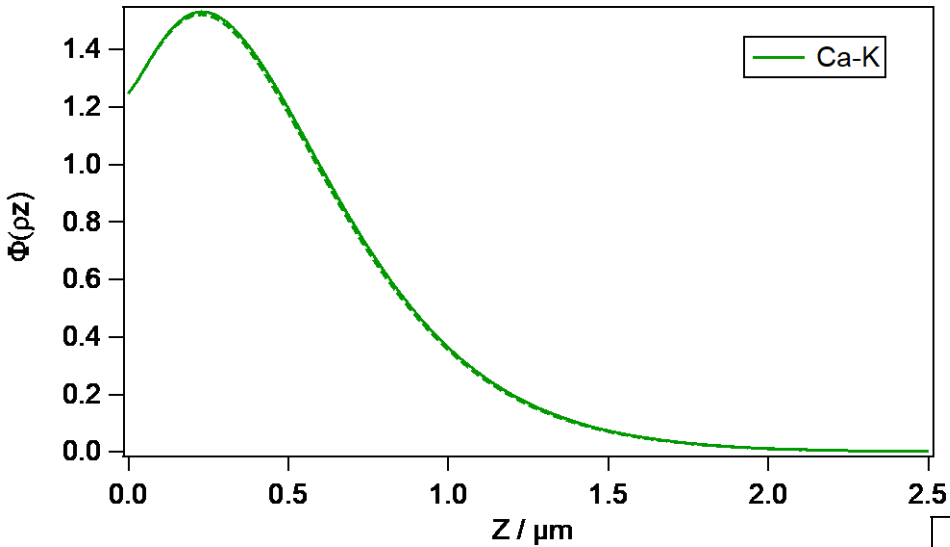
- $\Phi(\rho z)$ curves (generated/emitted) need to be used.



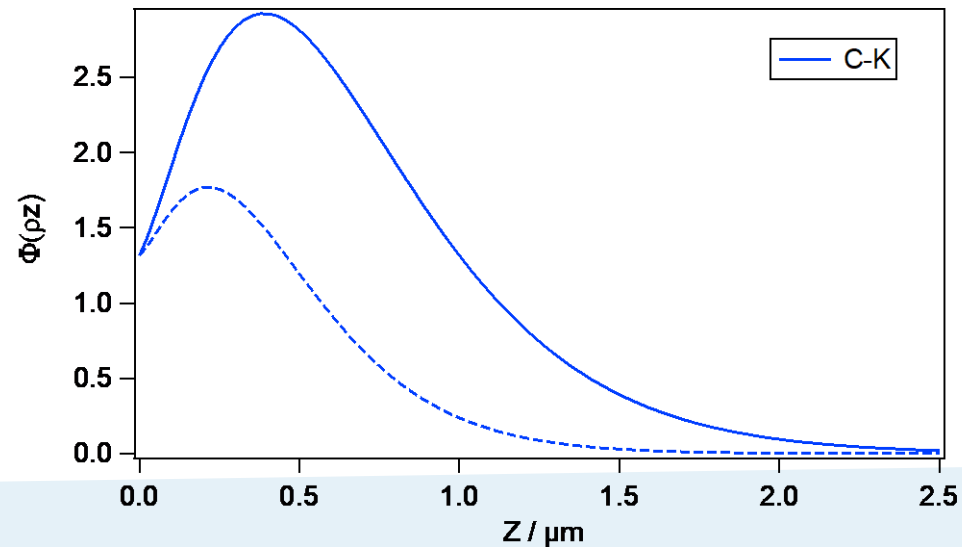
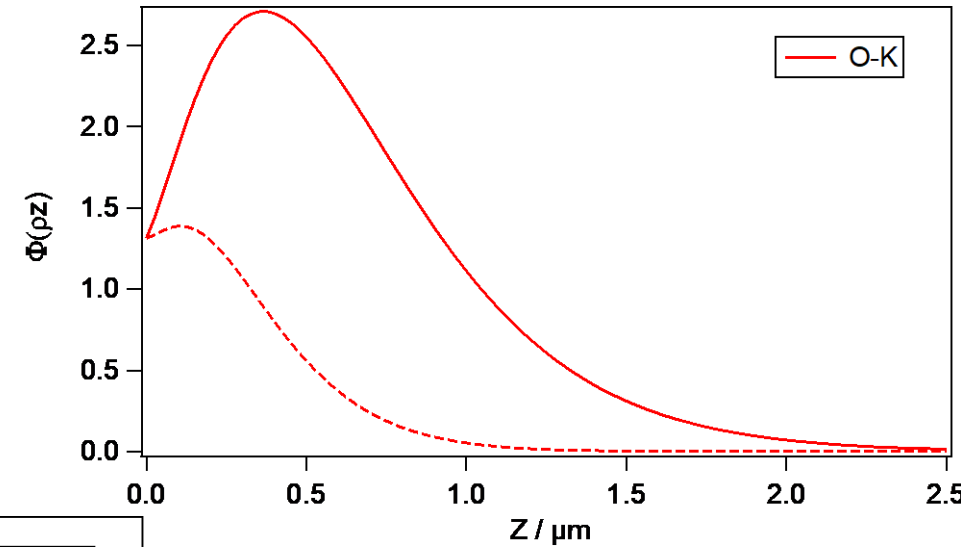
CaCO₃, 10kV

Absorption effect of Ca, C and O in CaCO_3

- $\Phi(\rho z)$ curves (generated /emitted) need to be used.



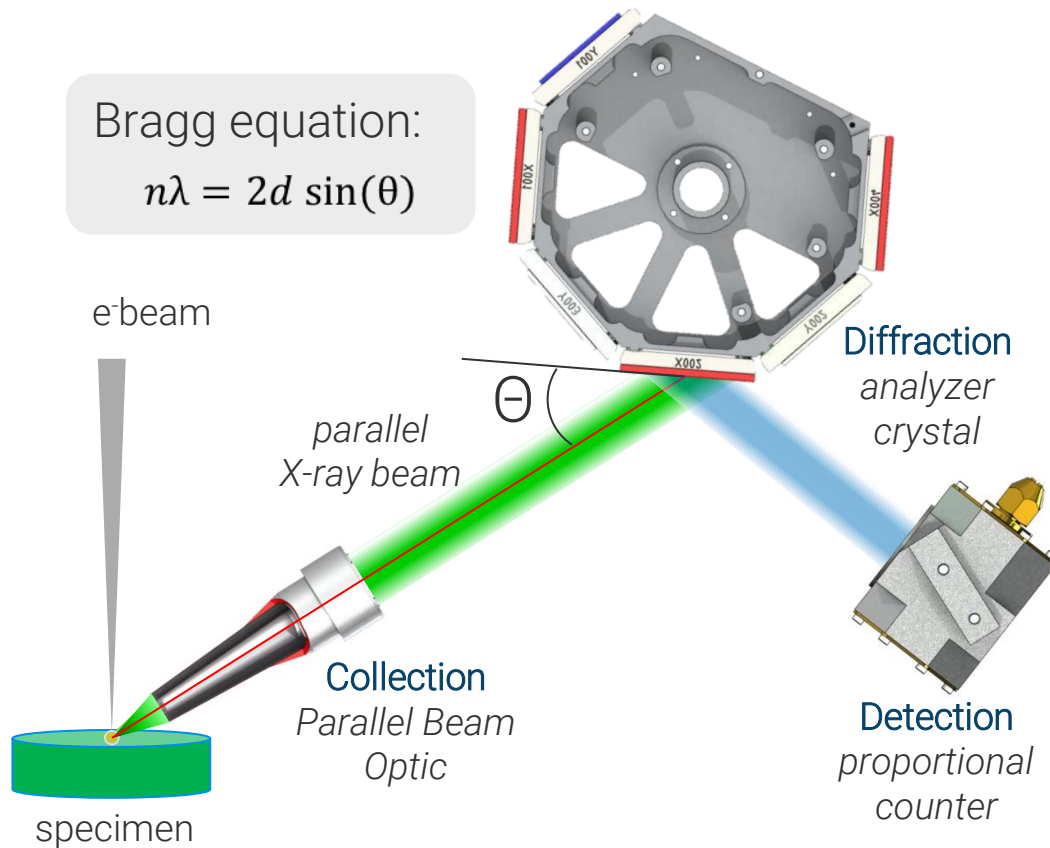
— Generated radiation
 - - - Emitted radiation



QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

QUANTAX WDS – technique and applications

Working principle of QUANTAX WDS



QUANTAX WDS

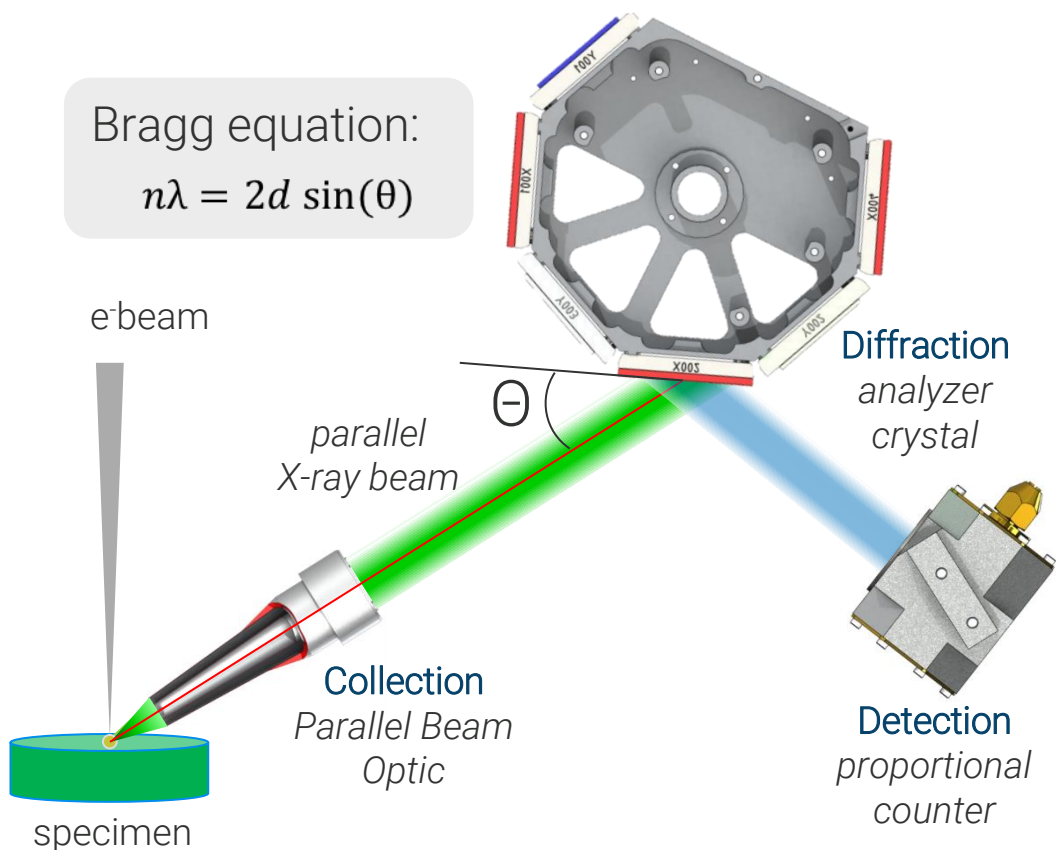


➔ QUANTAX WDS uses Bragg spectrometer and Parallel Beam Optic (PBO)

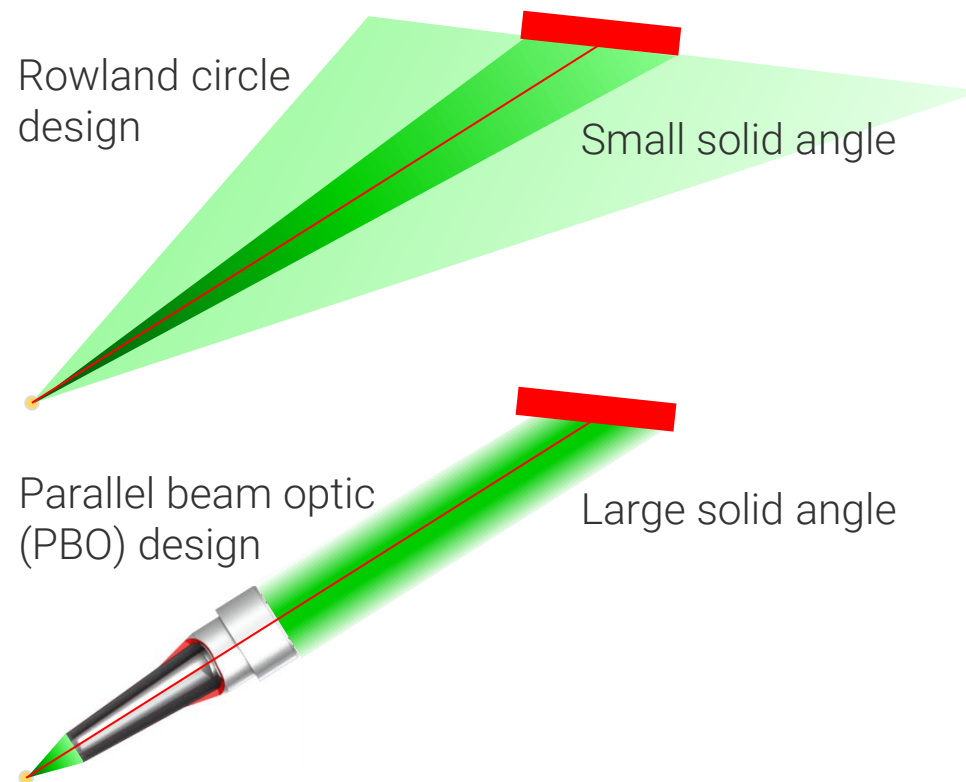
Working principle of QUANTAX WDS

Bragg equation:

$$n\lambda = 2d \sin(\theta)$$



Different WDS configurations

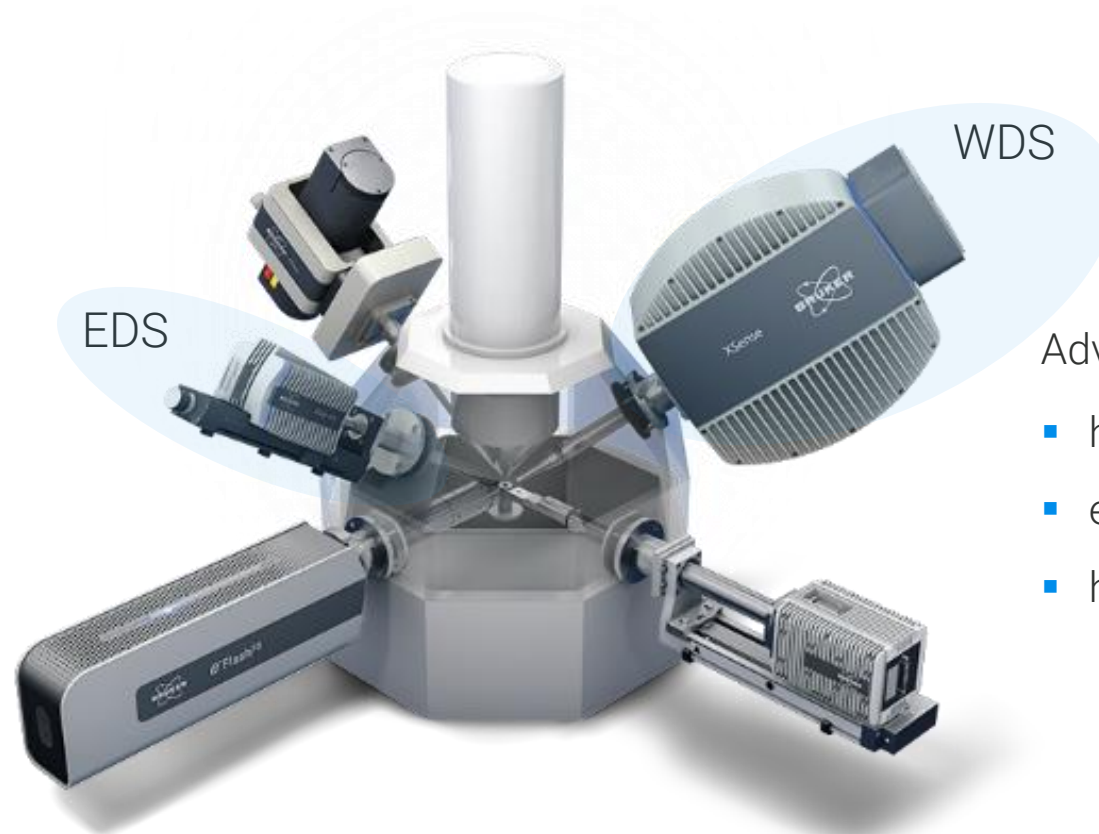


➔ Large solid angle with PBO results in high sensitivity for low X-ray energies

Advantages of combining QUANTAX WDS and QUANTAX EDS

Advantages of EDS:

- fast results
- simultaneous detection
- low beam currents

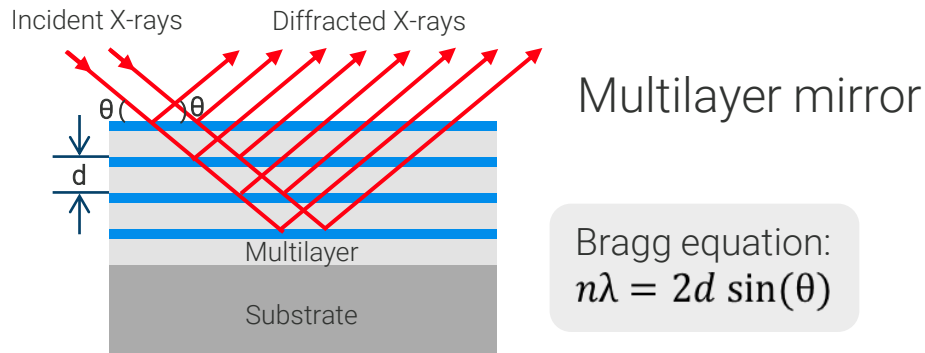
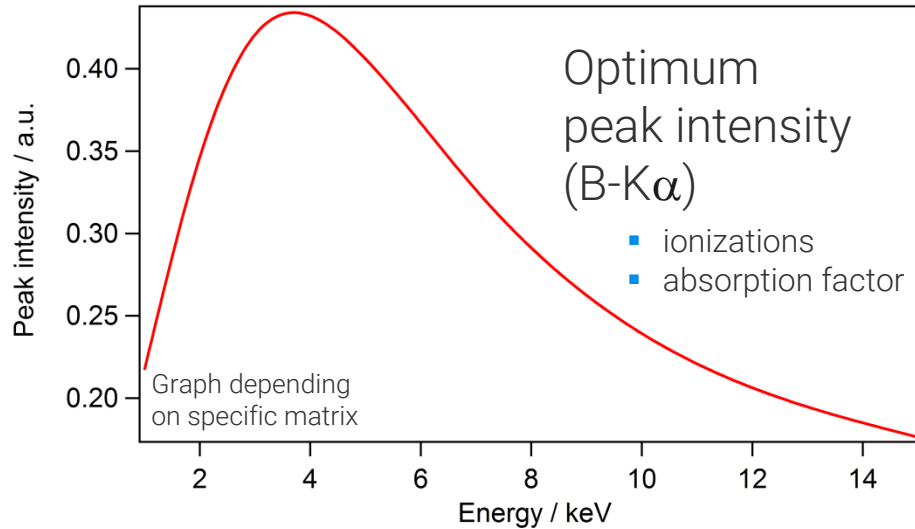


Advantages of WDS:

- higher spectral resolution
- enhanced P/B-ratios, i.e. lower LOD
- higher sensitivity for light elements

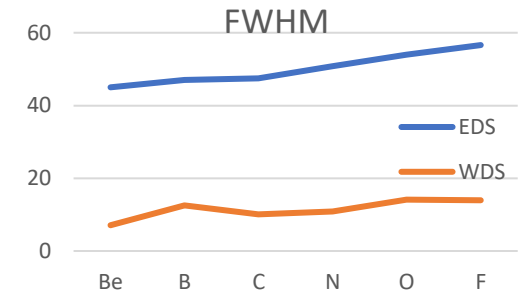
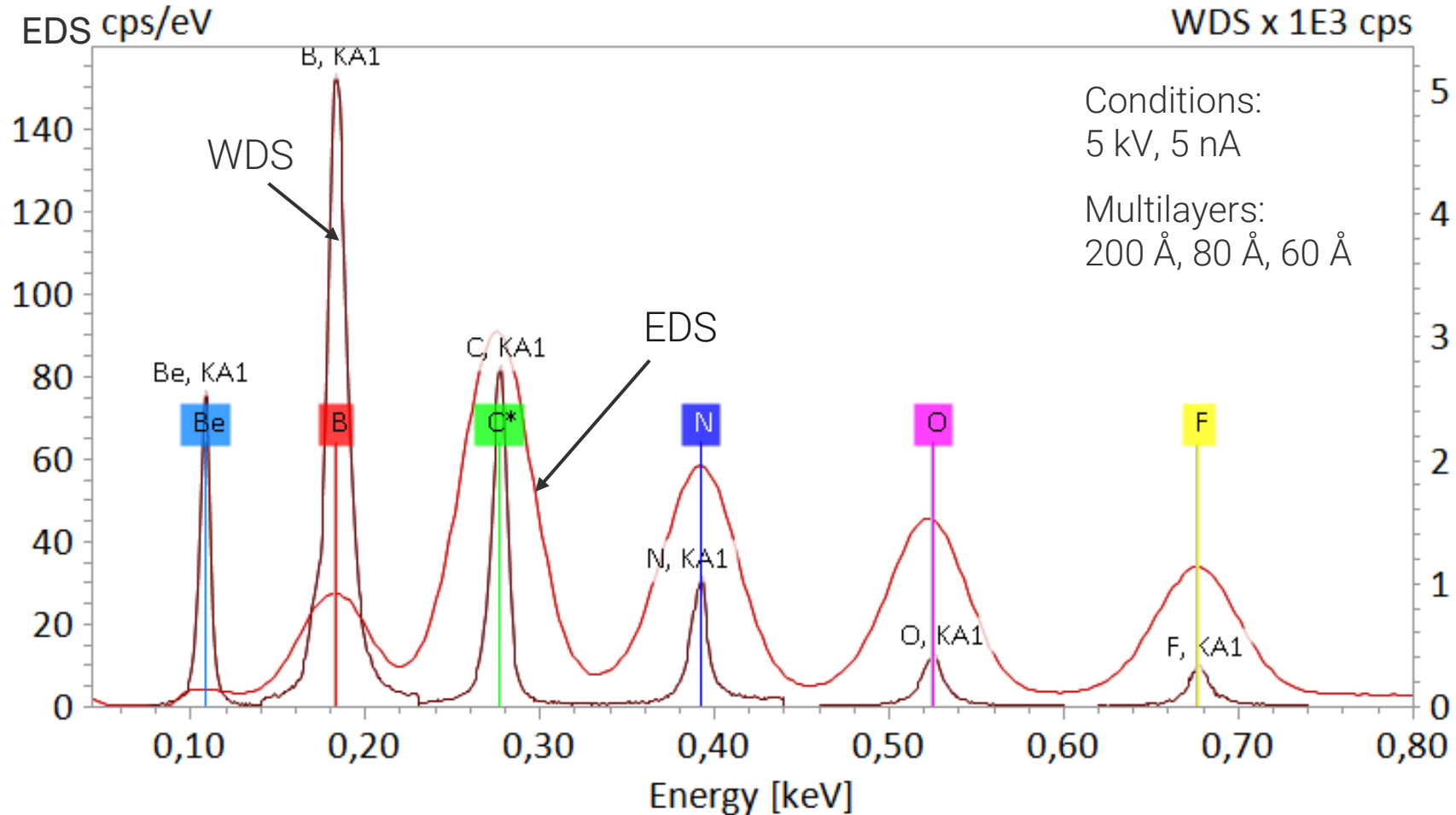
➔ WDS is an ideal technique to complement EDS in challenging applications

Analytical conditions for light elements



Typical parameters	
High voltage	5 kV
Beam current	5 nA
Monochromators	Multilayer 200, 80, 60
Standards	close to sample composition
Acquisition time Range	1 s (per step)
Acquisition time P/B	60 s (peak time)
Acquisition time Map	300 s (per element)

Light element spectra acquired by EDS and WDS



Samples:

Pure elements: Be, C and
compounds: BN, SiO₂, CaF₂

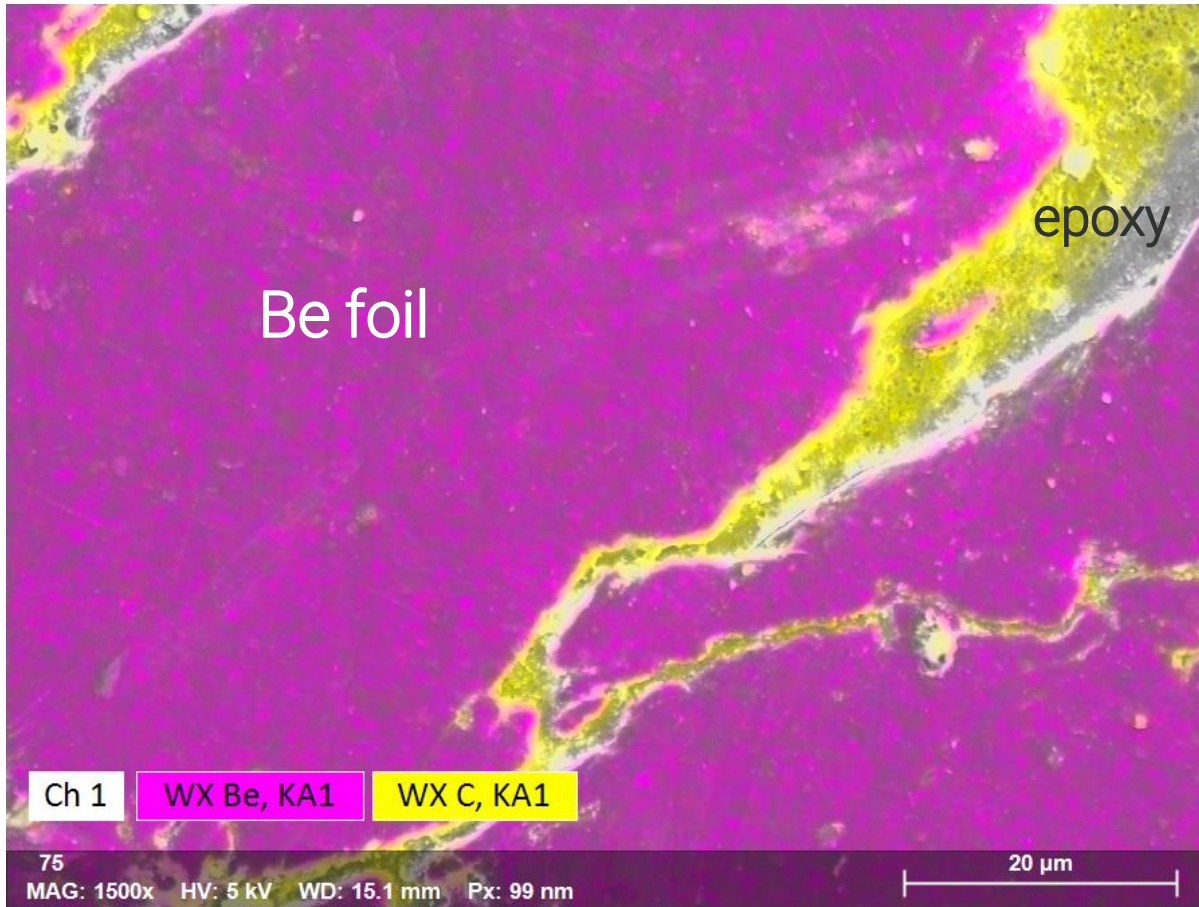
➔ WDS shows higher sensitivity, higher peak/background ratios and better spectral resolution

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Beryllium

WDS mapping of Beryllium

- Mapping a C-coated Be foil on epoxy resin

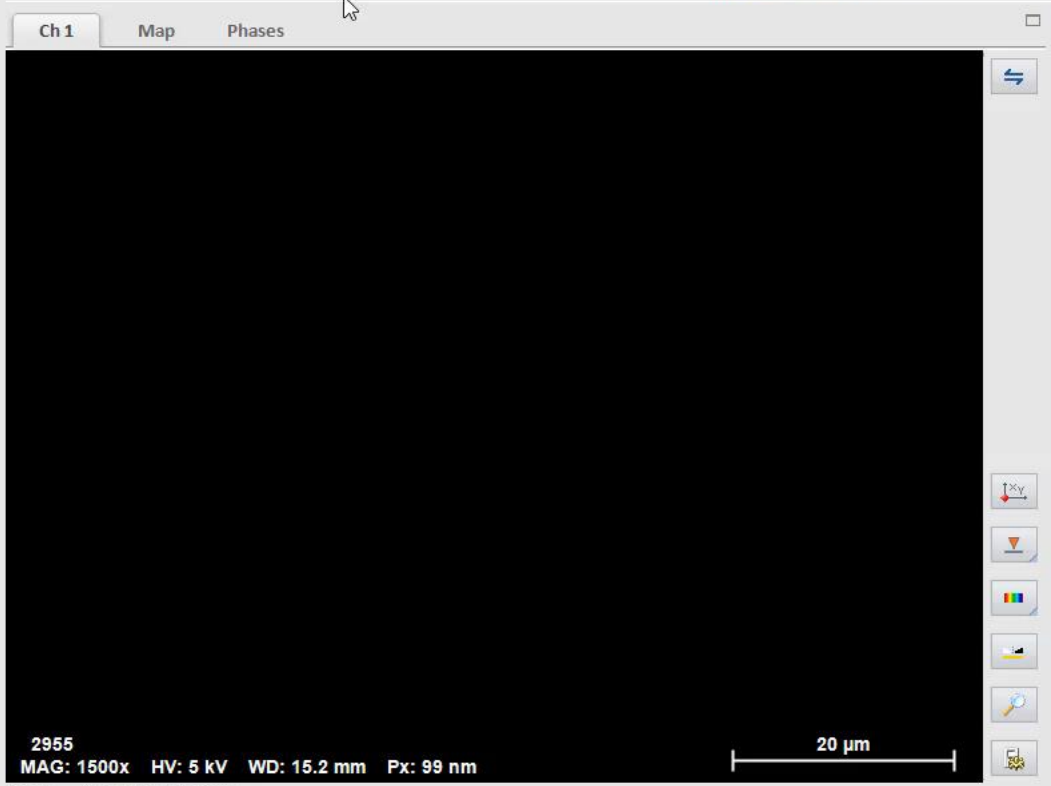


Analytical conditions	
FOV [µm]	89 x 66
Pixel	900 x 675
WD	15 mm
High voltage	5 kV
Beam current	8 nA
Acquisition time	Be-K α : 1 min C-K α : 1 min

➔ Light element mapping can be extremely fast

Sample Standards Standards_5 kV Microscope Scan EDS_1 EDS_2 WDS
HV 5.0 kV Size 900 px ICR 37.1 kcps ICR 41.6 kcps Energy 277.0 eV

Preview Capture Acquire QMap EDS Linemarker PB-ZAF



0.12 µm Spot size 902x676 Points

Ch 1 1.00 WX Be, KA1 1.00 WX C, KA1 1.00 C-K 1.00 O-K 1.00 Na-K 1.00 Si-Kα 1.00

Map display settings

Map result list

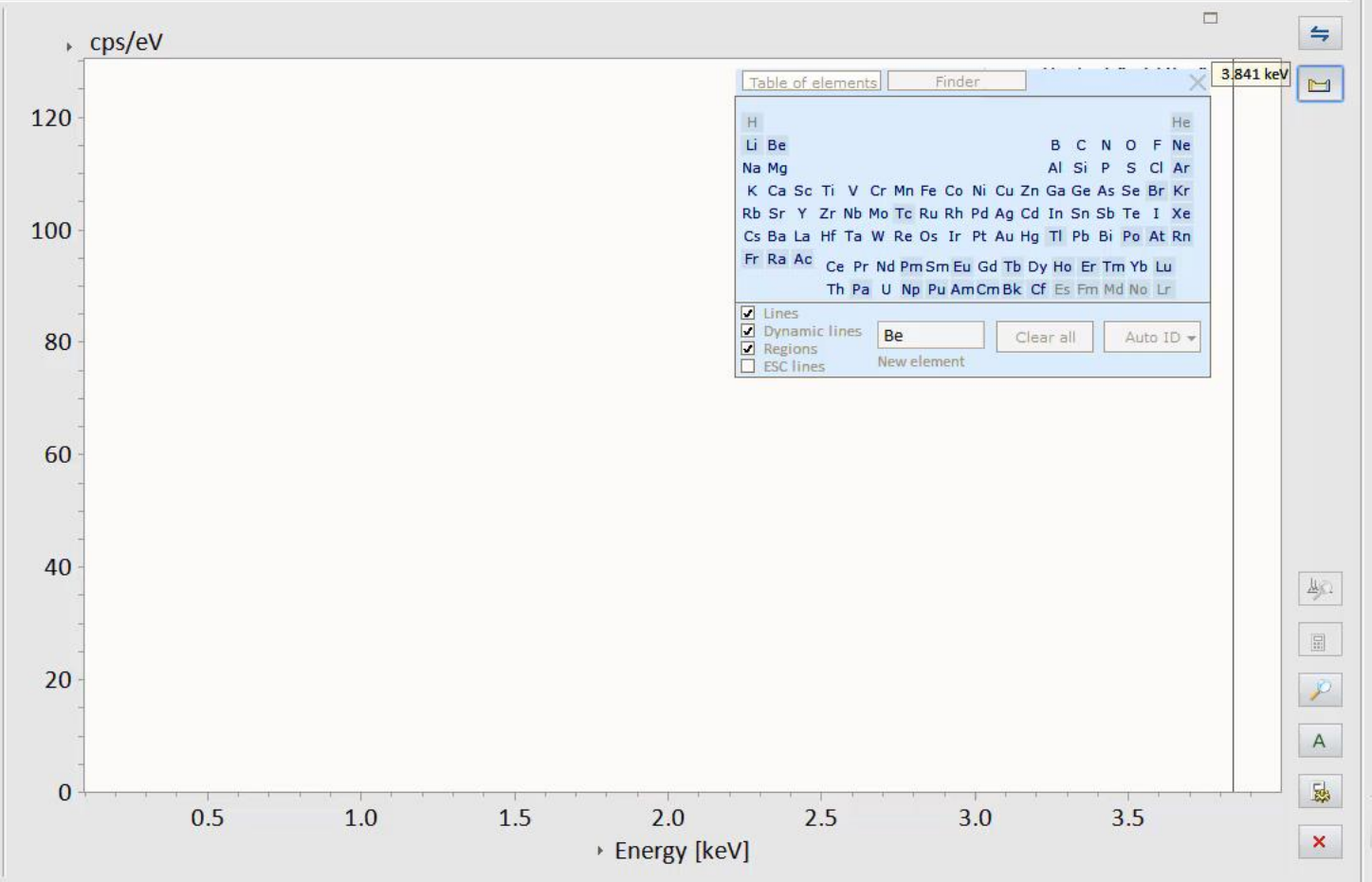
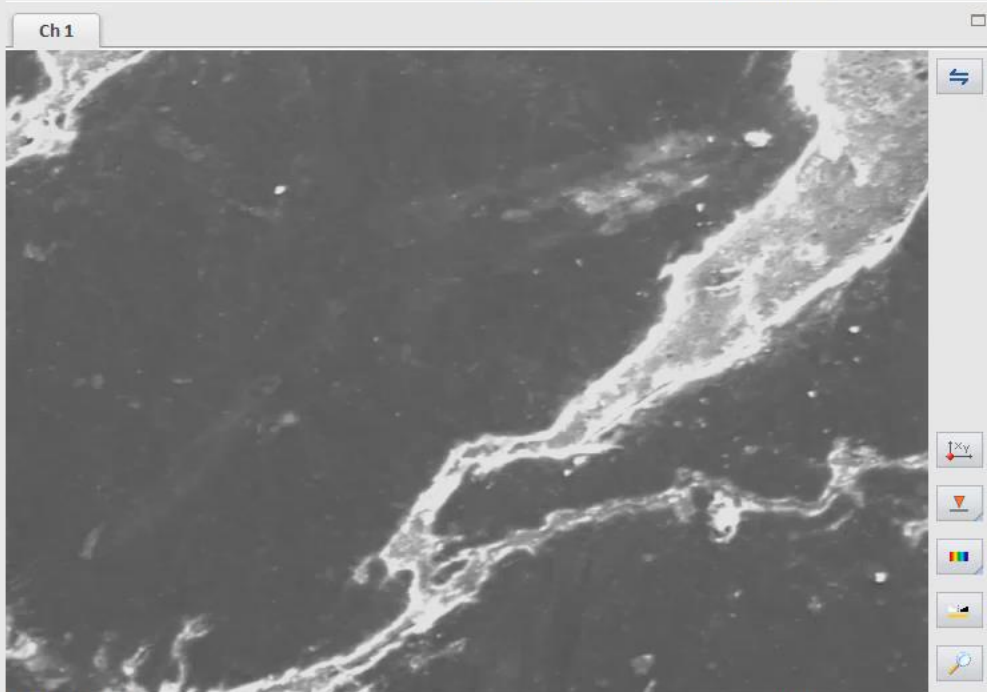
Table of elements		Finder	
H	Free regions	Counts	Standard
Li	Be	F1	F2
Na	Mg	F3	F4
K	Ca	F5	F6
Rb	Sr	F7	F8
Cs	Ba	B	C
Fr	Ra	N	O
		F	Ne
		P	S
		Cl	Ar
		Al	Si
		P	S
		Cl	Ar
		K	Ca
		Sc	Ti
		V	Cr
		Mn	Fe
		Co	Ni
		Cu	Zn
		Ga	Ge
		As	Se
		Br	Kr
		Rb	Sr
		Y	Zr
		Nb	Mo
		Tc	Ru
		Rh	Pd
		Ag	Cd
		In	Sn
		Sb	Te
		I	Xe
		Cs	Ba
		La	Hf
		Ta	W
		Re	Os
		Ir	Pt
		Au	Hg
		Tl	Pb
		Bi	Po
		At	Rn
		Fr	Ra
		Ac	Ce
		Pr	Nd
		Pm	Sm
		Eu	Gd
		Tb	Dy
		Ho	Er
		Tm	Yb
		Lu	Th
		Pa	U
		Np	Pu
		Am	Cm
		Bk	Cf
		Es	Fm
		Md	No
		Lr	

Lines
 Dynamic lines
 Regions
 ESC lines

Si Clear all Auto ID

Sample: Be-foil
Standards: Standards_5 kV
Microscope: HV 5.0 kV
Scan: Size 900 px
EDS_1: ICR 38.0 kcps
EDS_2: ICR 41.6 kcps
WDS: Energy 125.0 eV

Preview
Capture
Acquire
Quantify



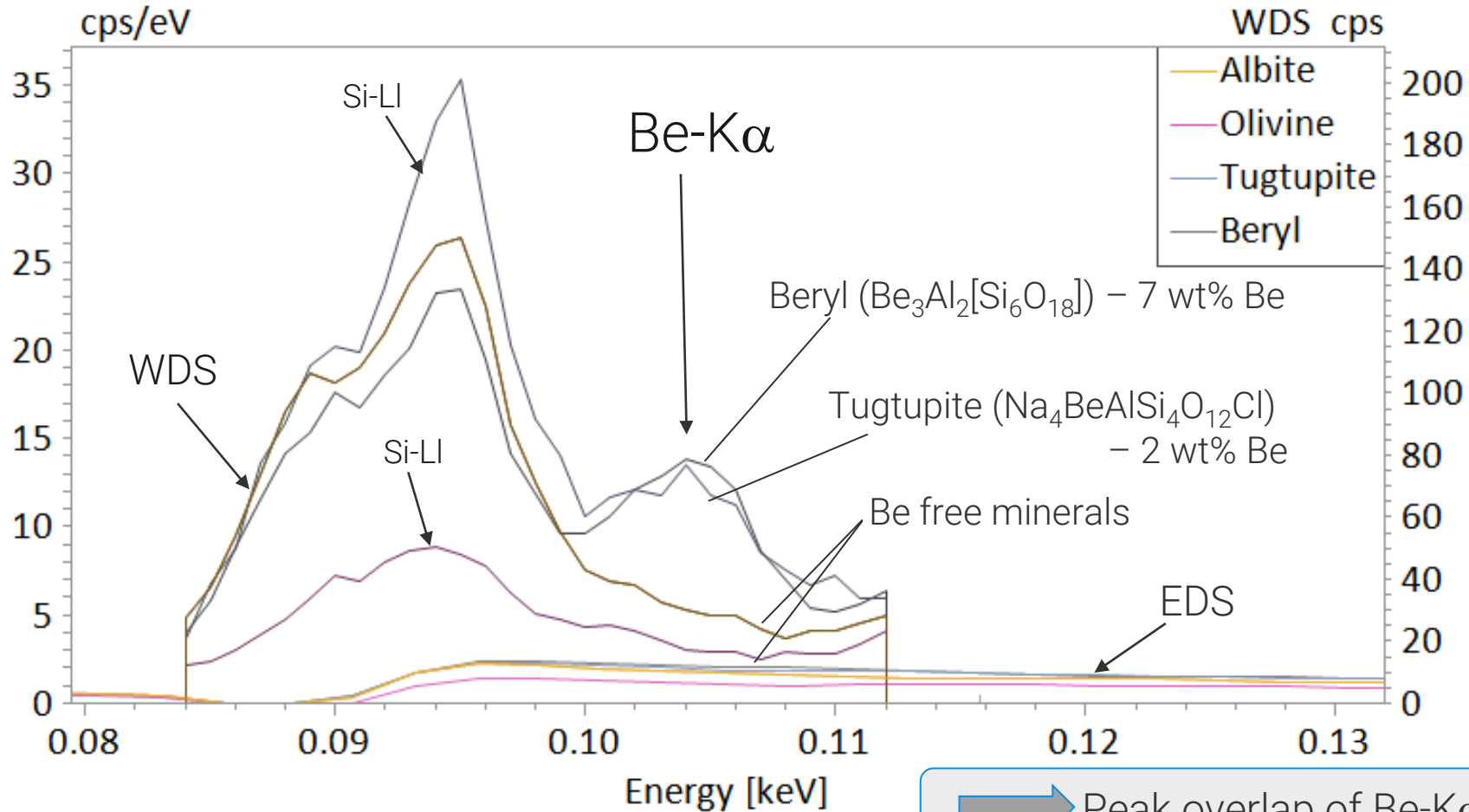
Select all
Delete
Copy

Grid
 Random
 Both

All
 cps/eV
Real
Live
Dead
Pulses
Input
Output
Max. pulse throughput

Beryllium-minerals vs. Be-free minerals

- WDS energy range scan for Be-K α



5 kV, 17 nA
Dwell time:
10 s / step

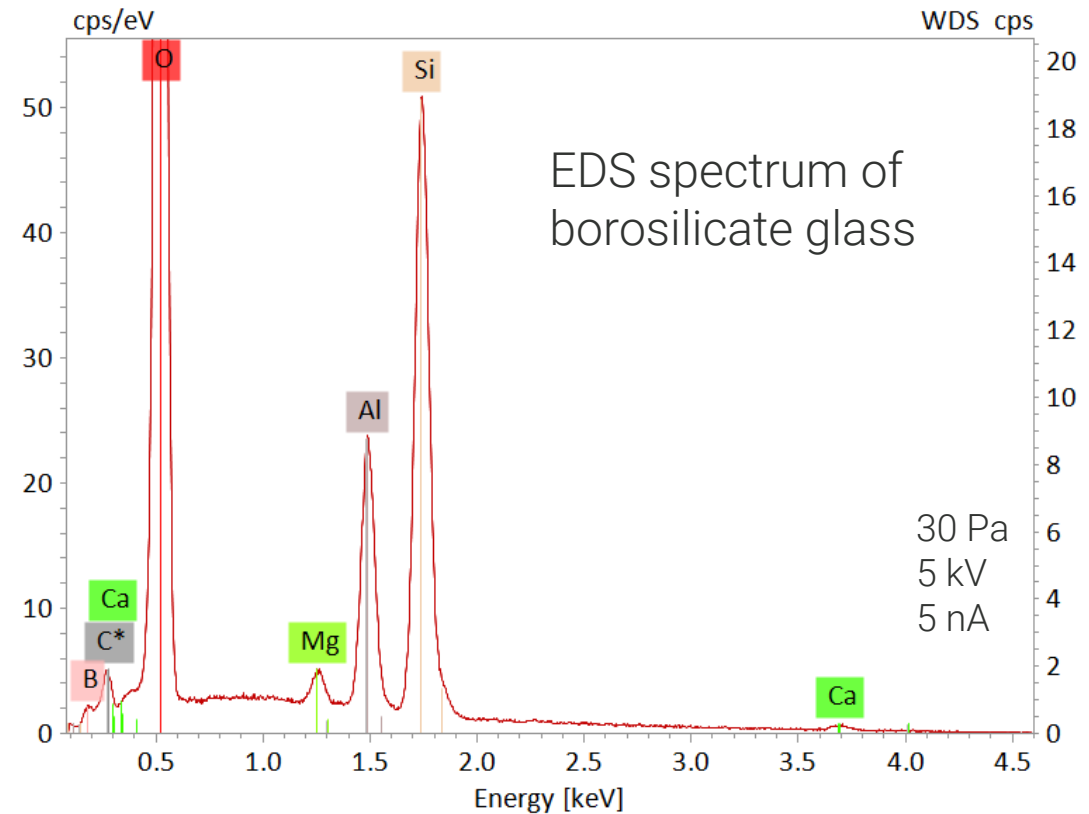
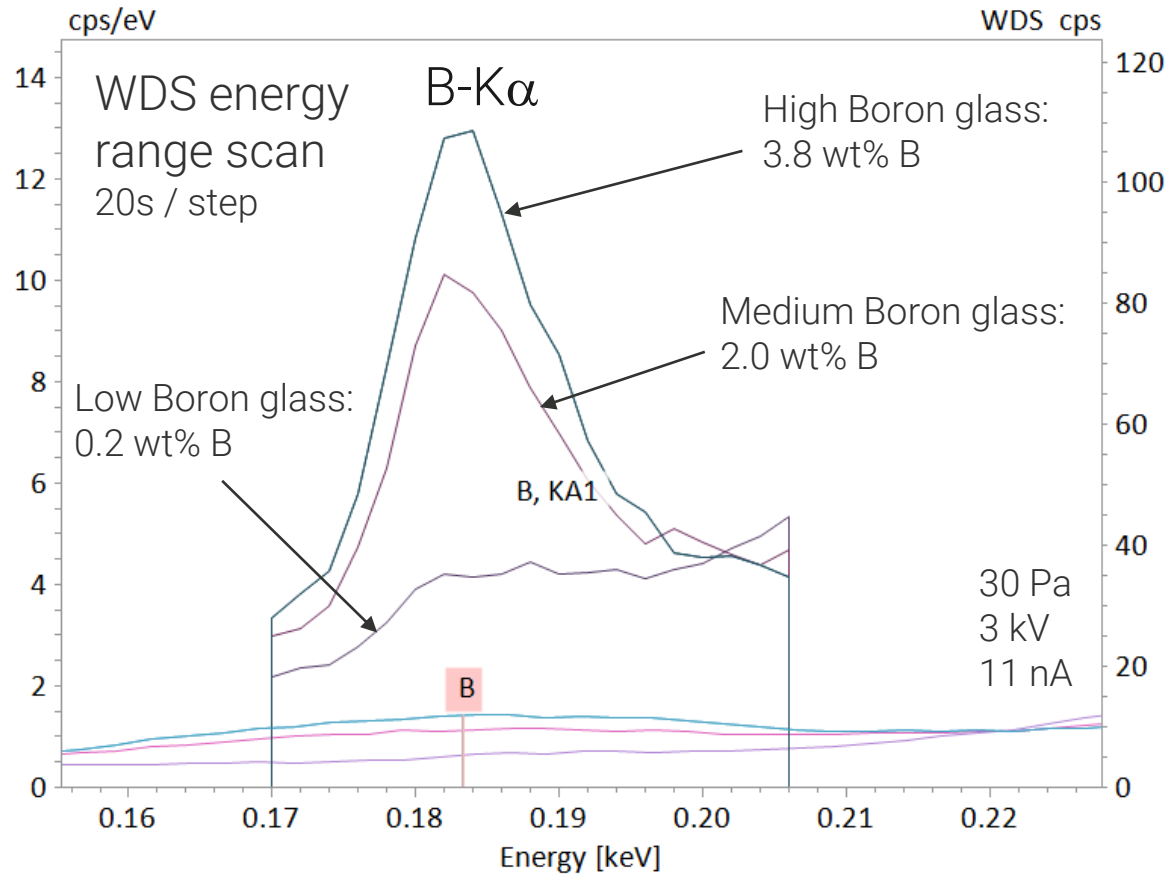
➔ Peak overlap of Be-K α and Si-L is resolved

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Boron

Boron in glasses

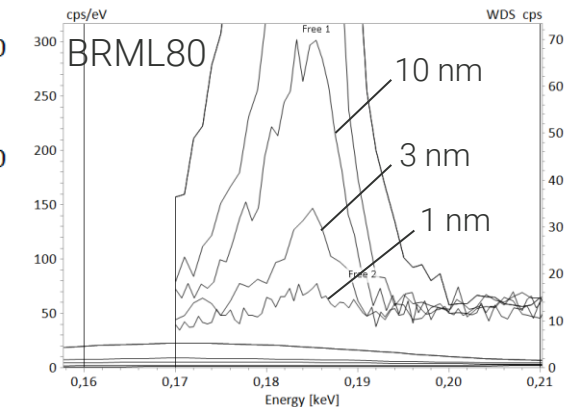
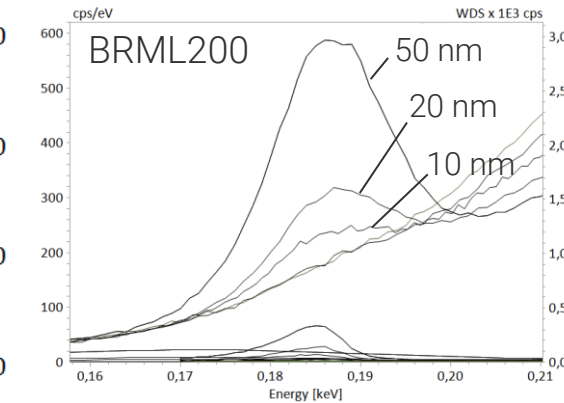
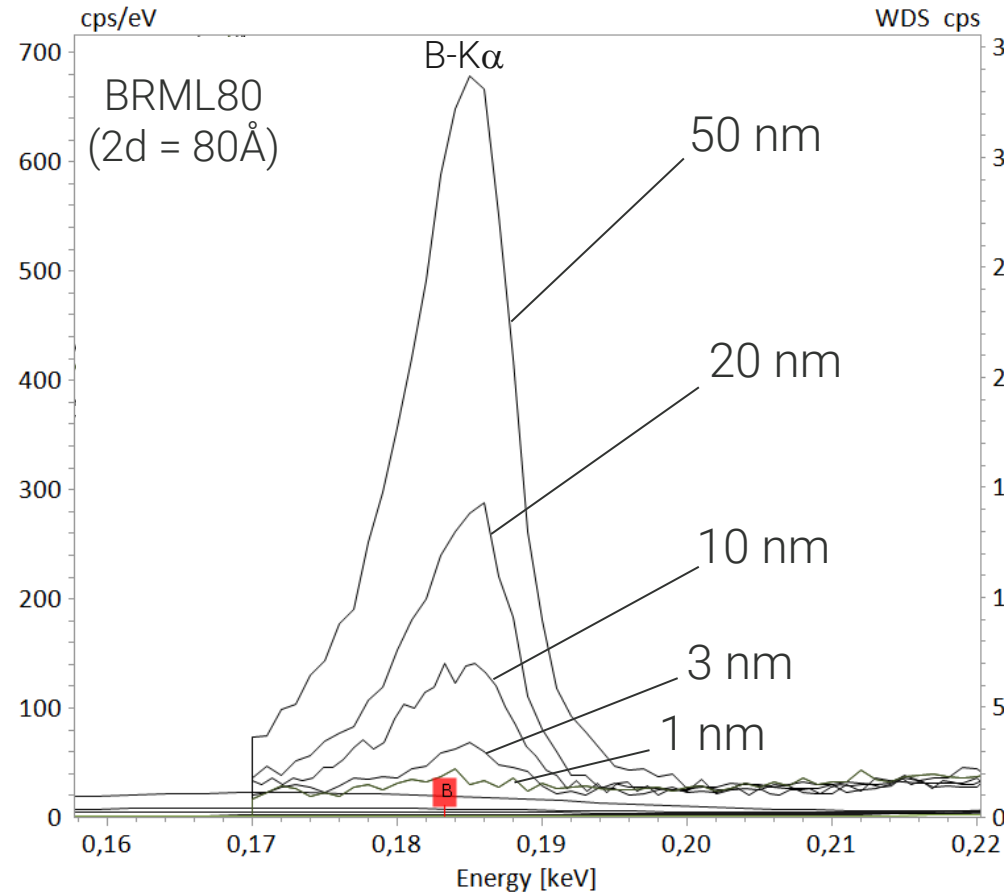
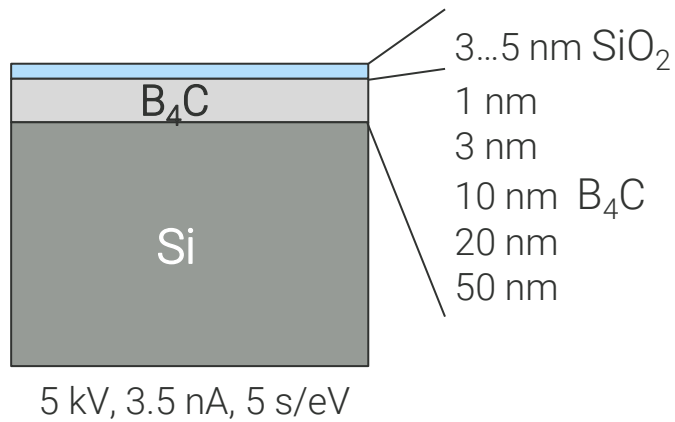
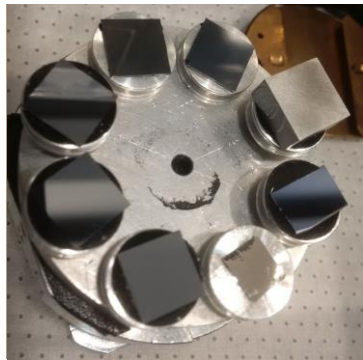
- Low-vacuum analyses of uncoated glasses



➔ WDS can successfully quantify low B contents in glass

Boron in layered samples

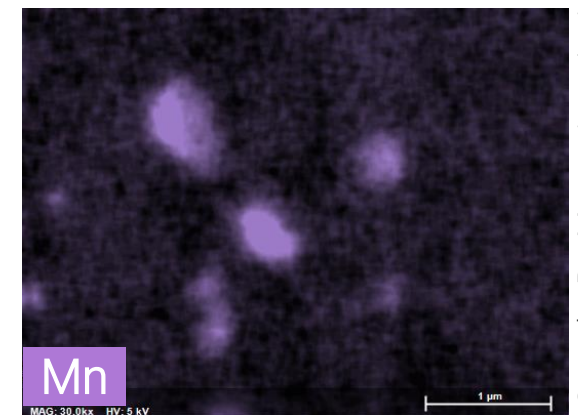
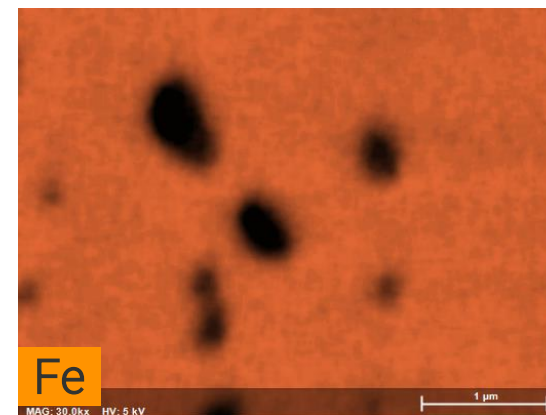
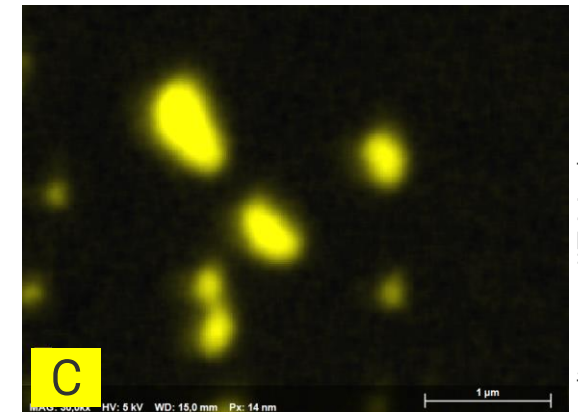
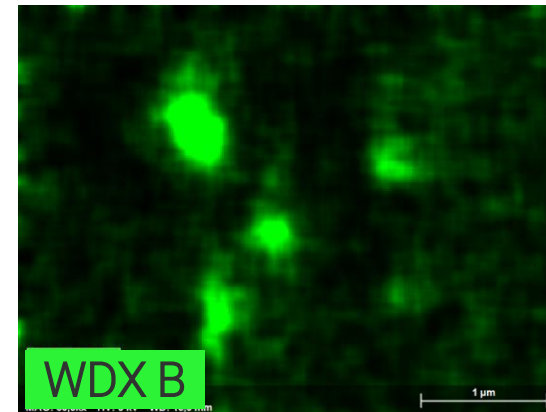
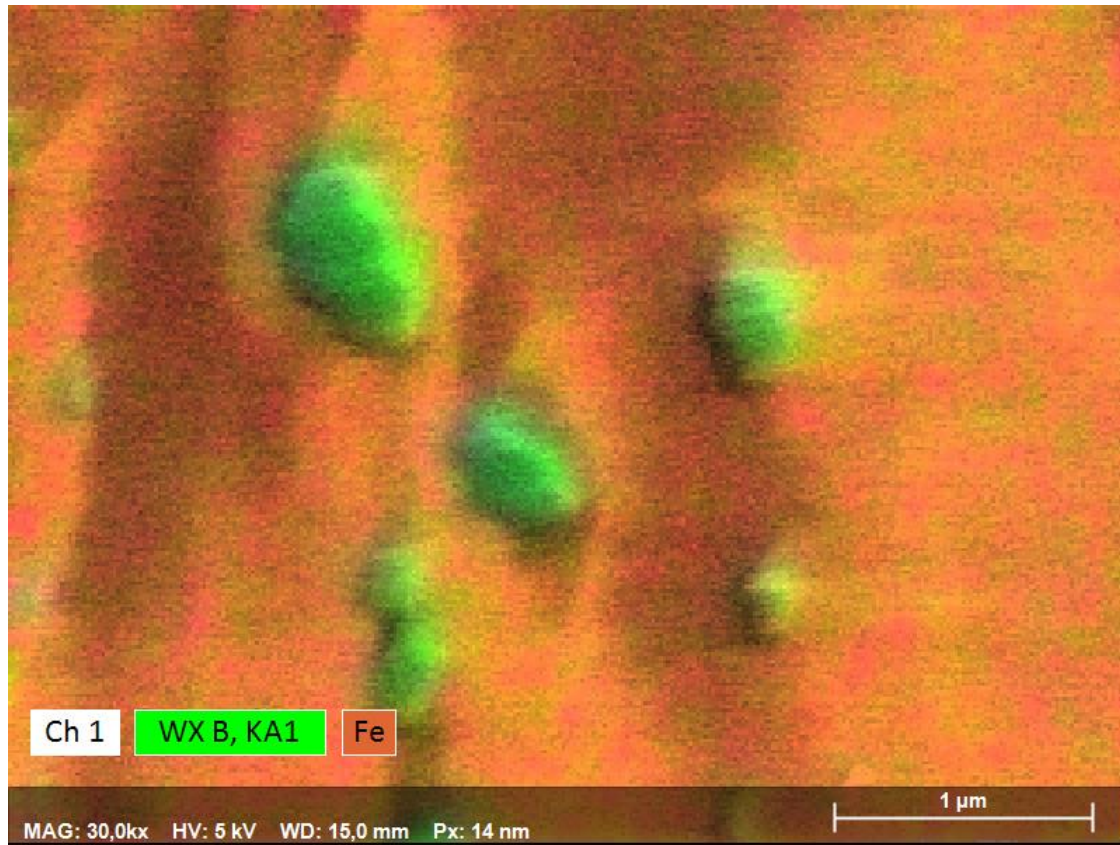
- Detection of Boron in thin B₄C layers



➔ Evidence for Boron down to the thinnest layer

Boron in steel

- Combined WDS – EDS mapping of a Boron steel



Cementite (Fe_3C): 0.4 wt% B, matrix steel: 0.2 wt% B
 300 x 225 px, 225 $\mu s/px$, 120 min/map

→ Heterogeneous Boron distribution on sub-micron scale

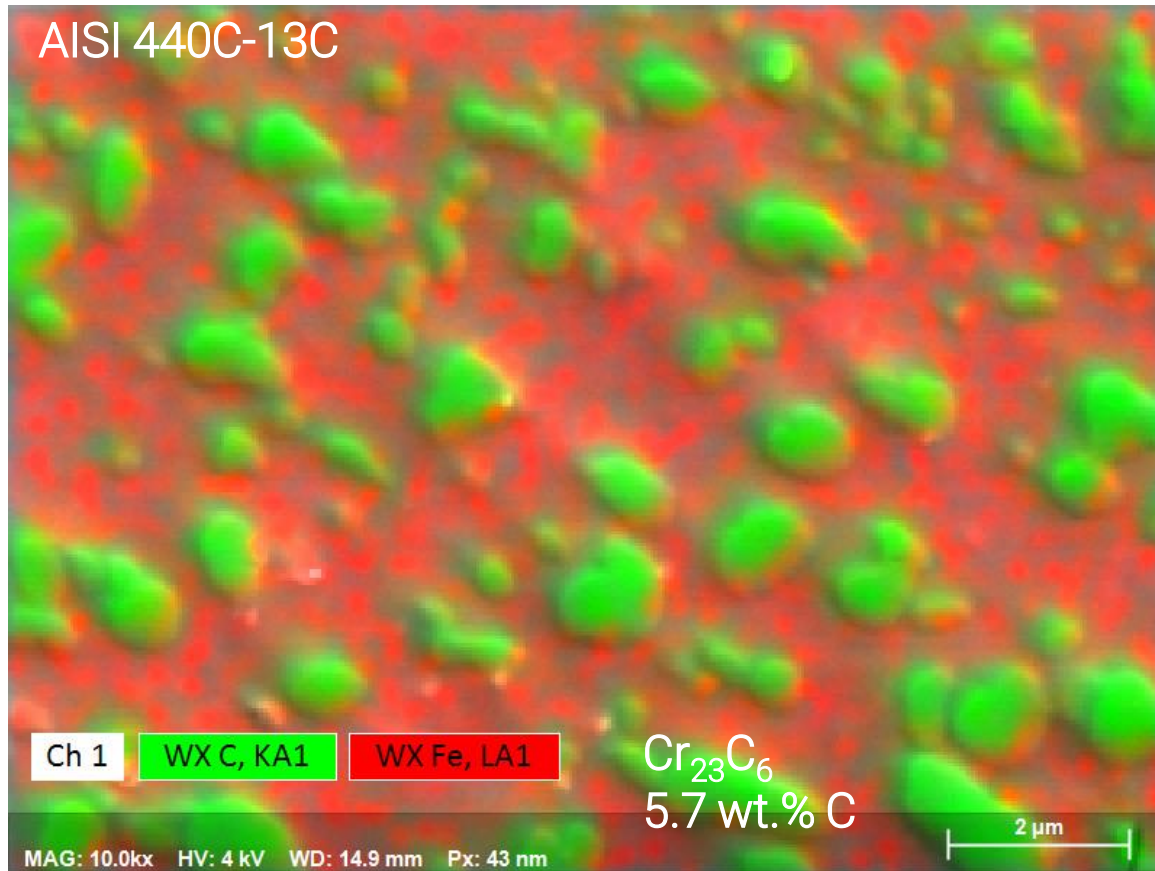
Sample: Dr. Murugaiyan Amirthalingam, IIT Madras

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Carbon

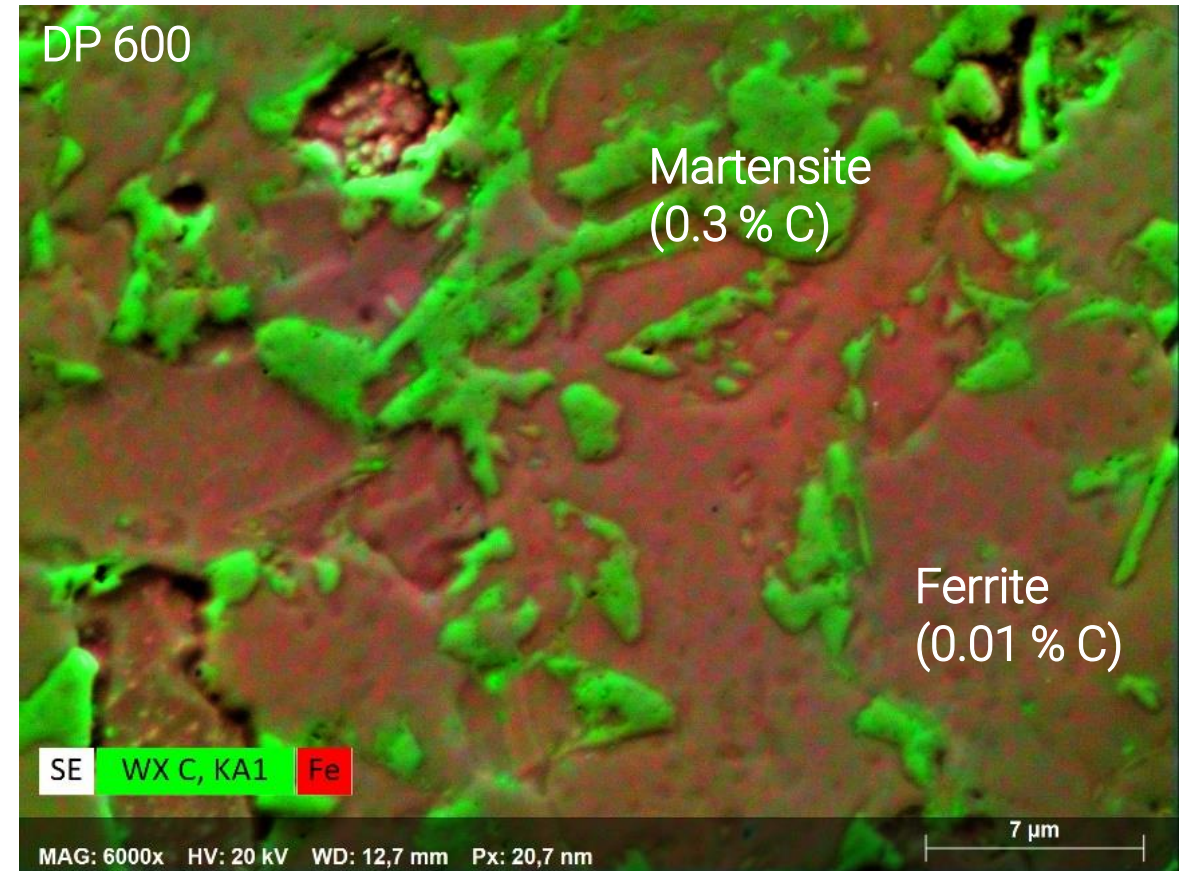
Mapping carbon distribution in steel

- Carbide bearing steel



5 min mapping

- Dual phase steel

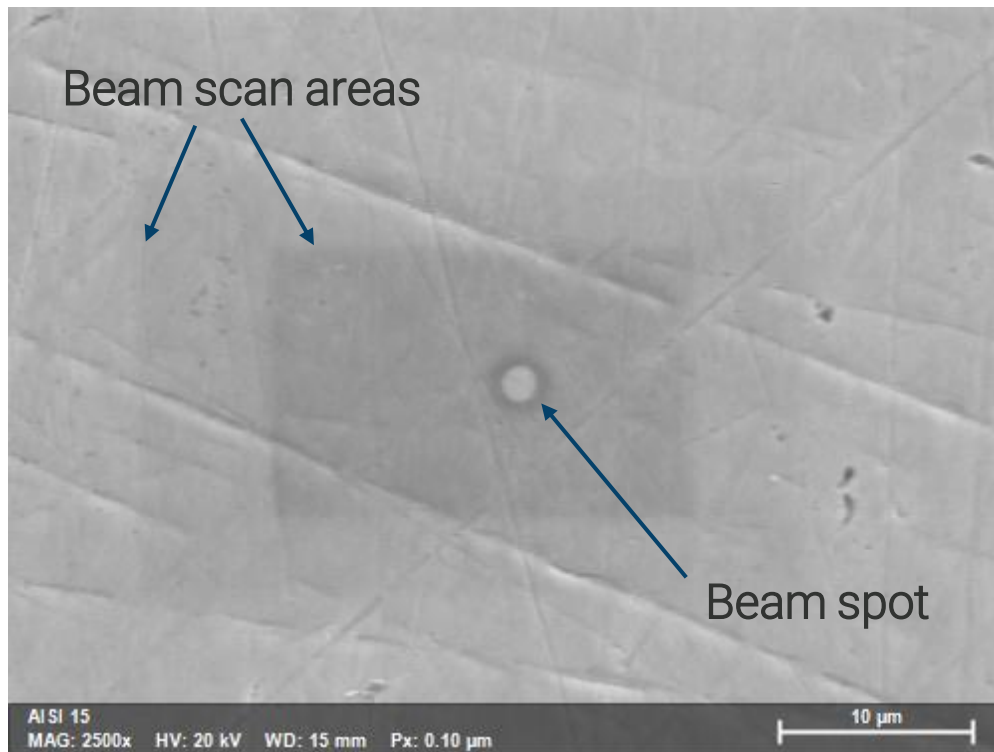


Sample: TU Eindhoven – 5 min

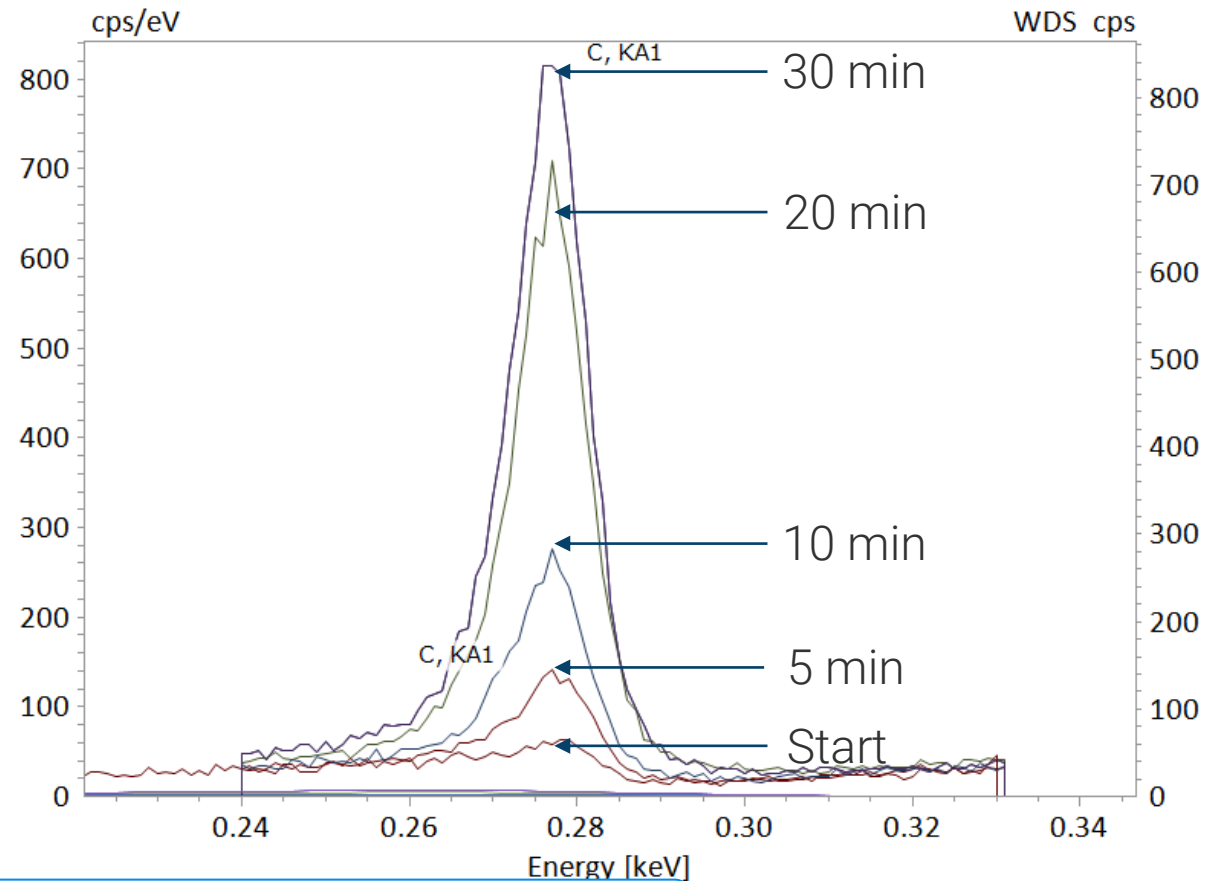
➔ Fast mapping is possible and preferred to minimize contamination

Carbon contamination during analysis

- Carbon contamination on sample surface



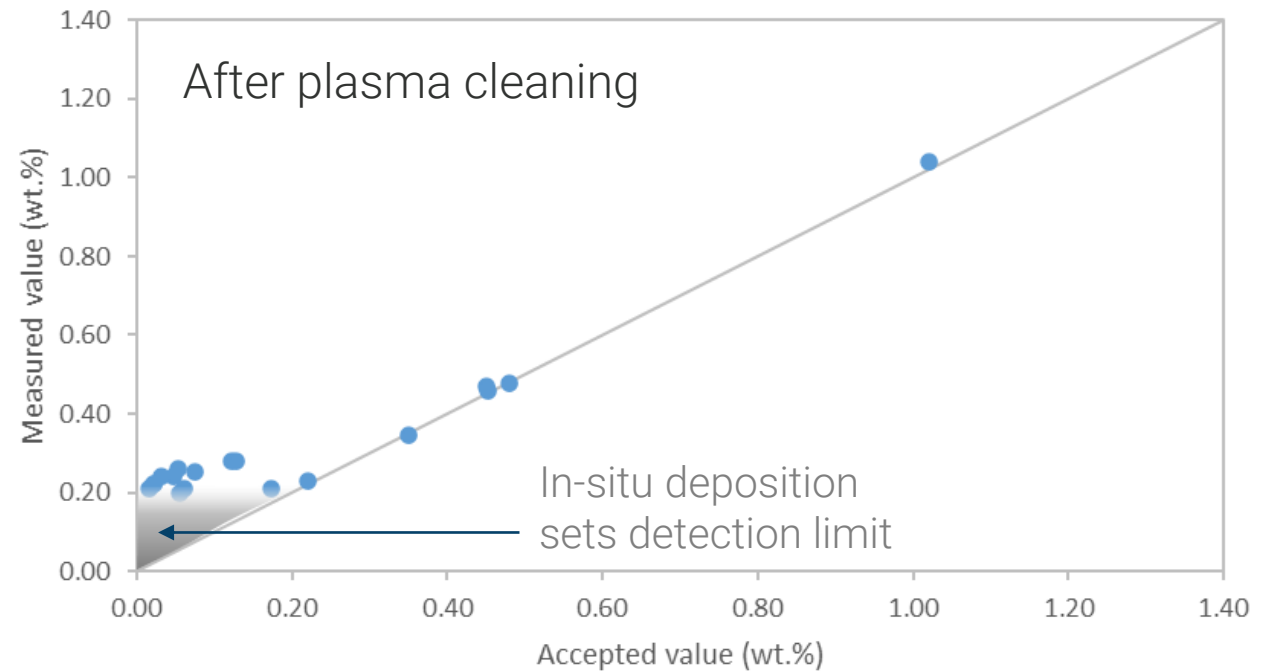
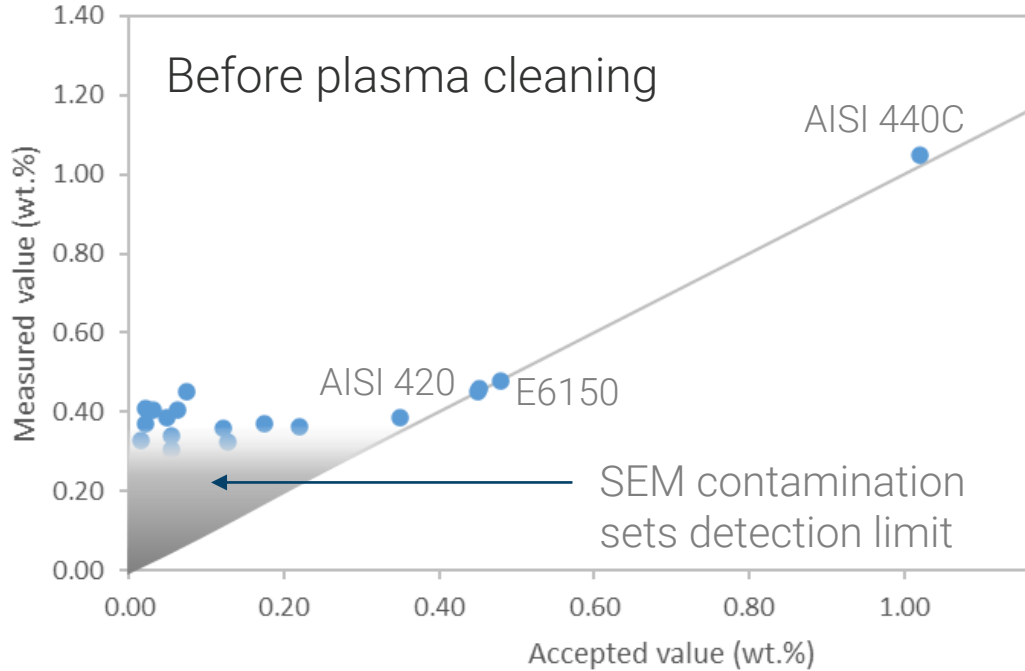
- Increasing carbon deposition over time



➡ Carbon is instantaneously deposited on the area of analysis

Carbon contents in steel

- Carbon quantification is a challenge for analysis on SEM



Note: Further improvement possible with air jet and cold finger

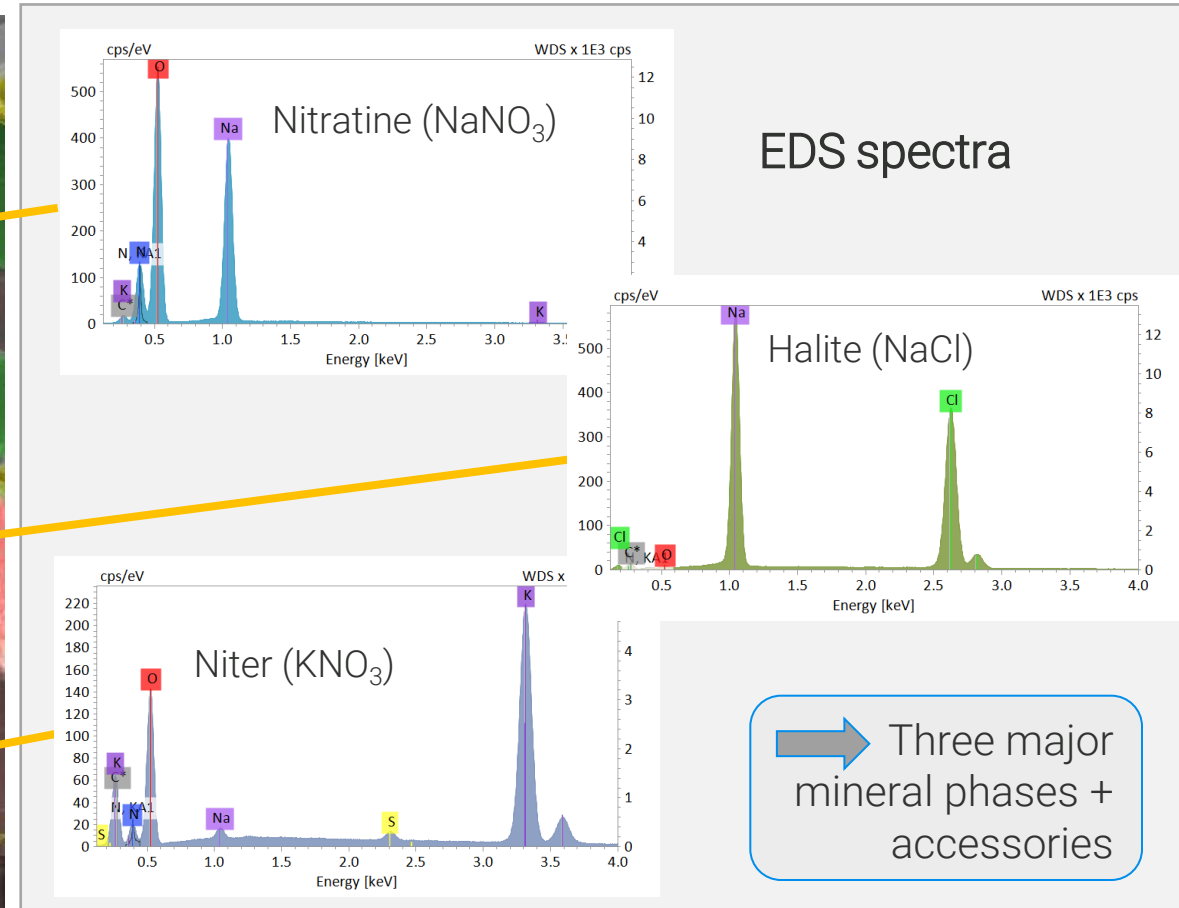
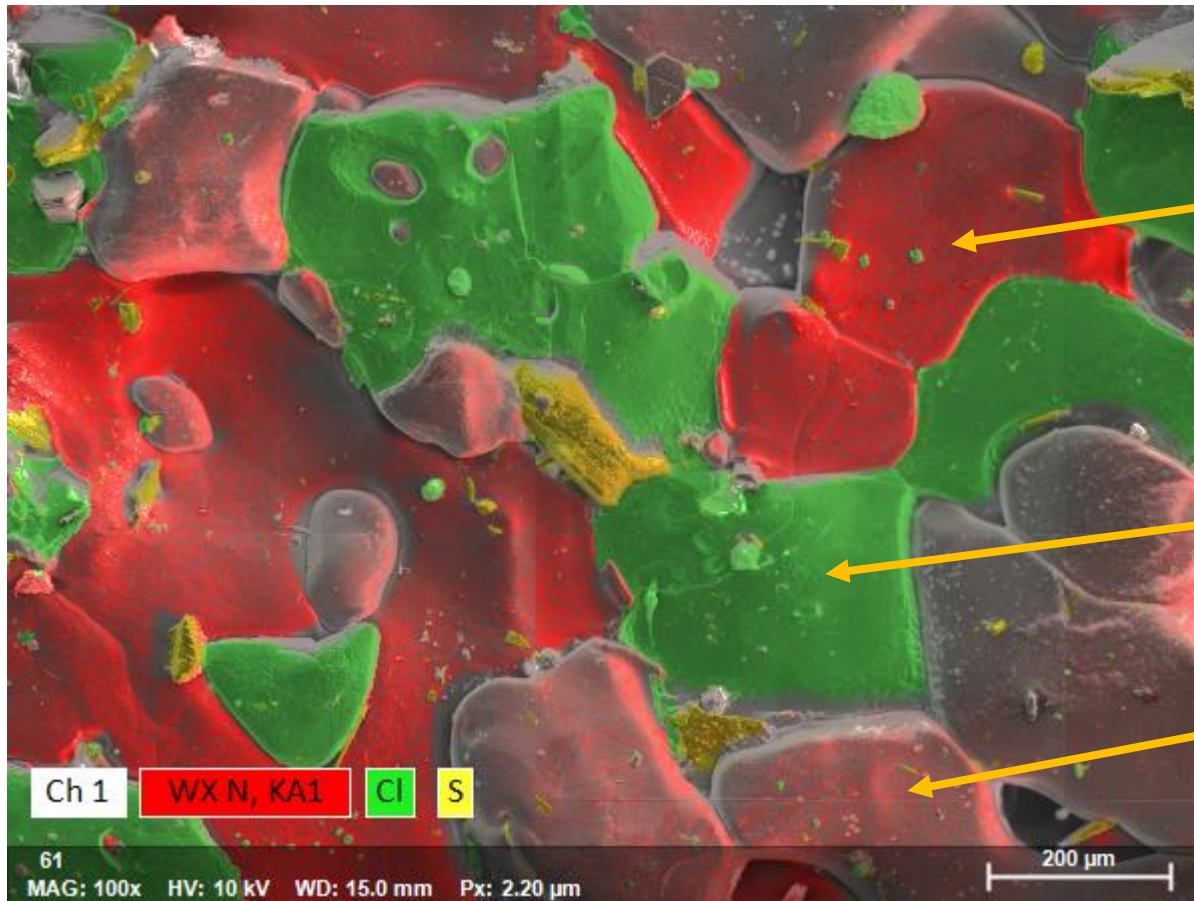
➔ The LOD for Carbon depends on technical measures to lower contamination

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Nitrogen

Nitrogen in minerals

- Combined WDS – EDS mapping of caliche ore from Atacama, Chile

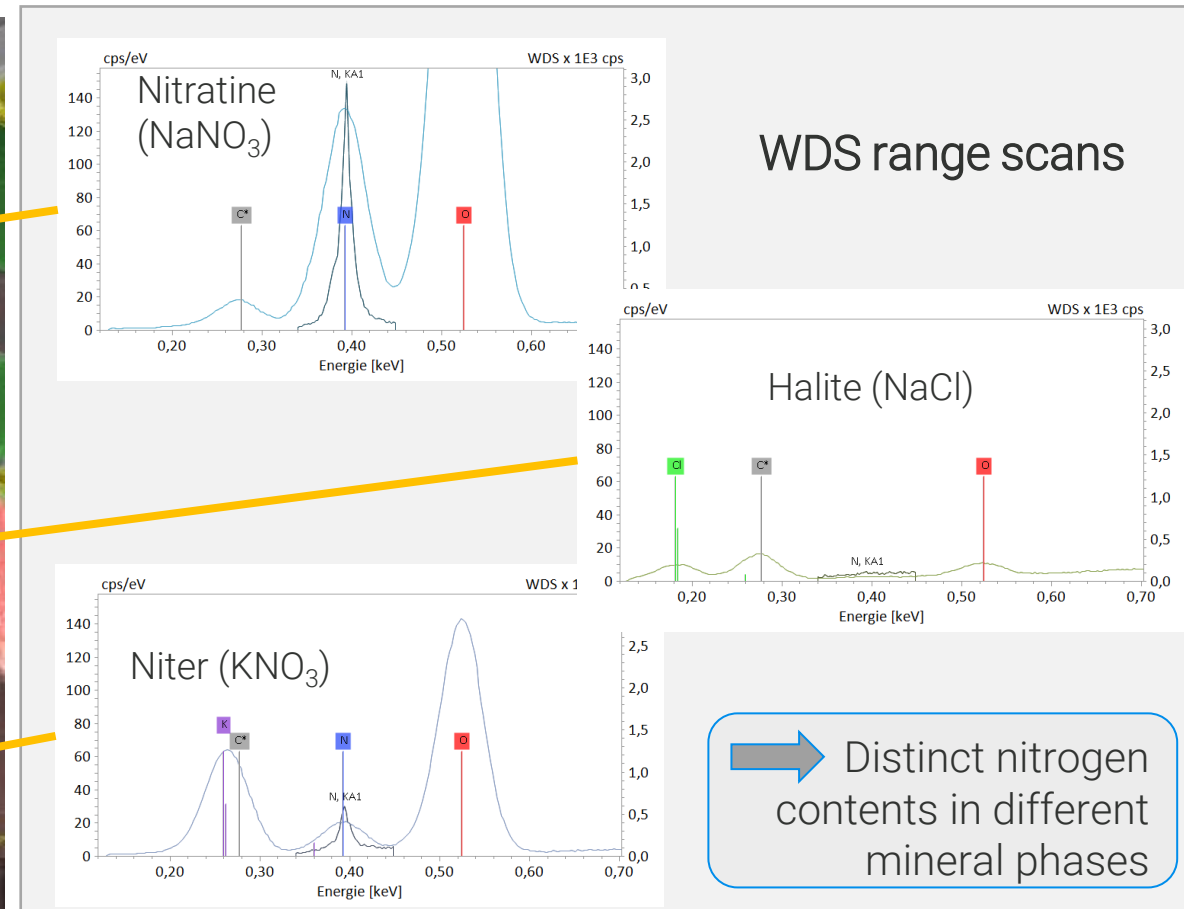
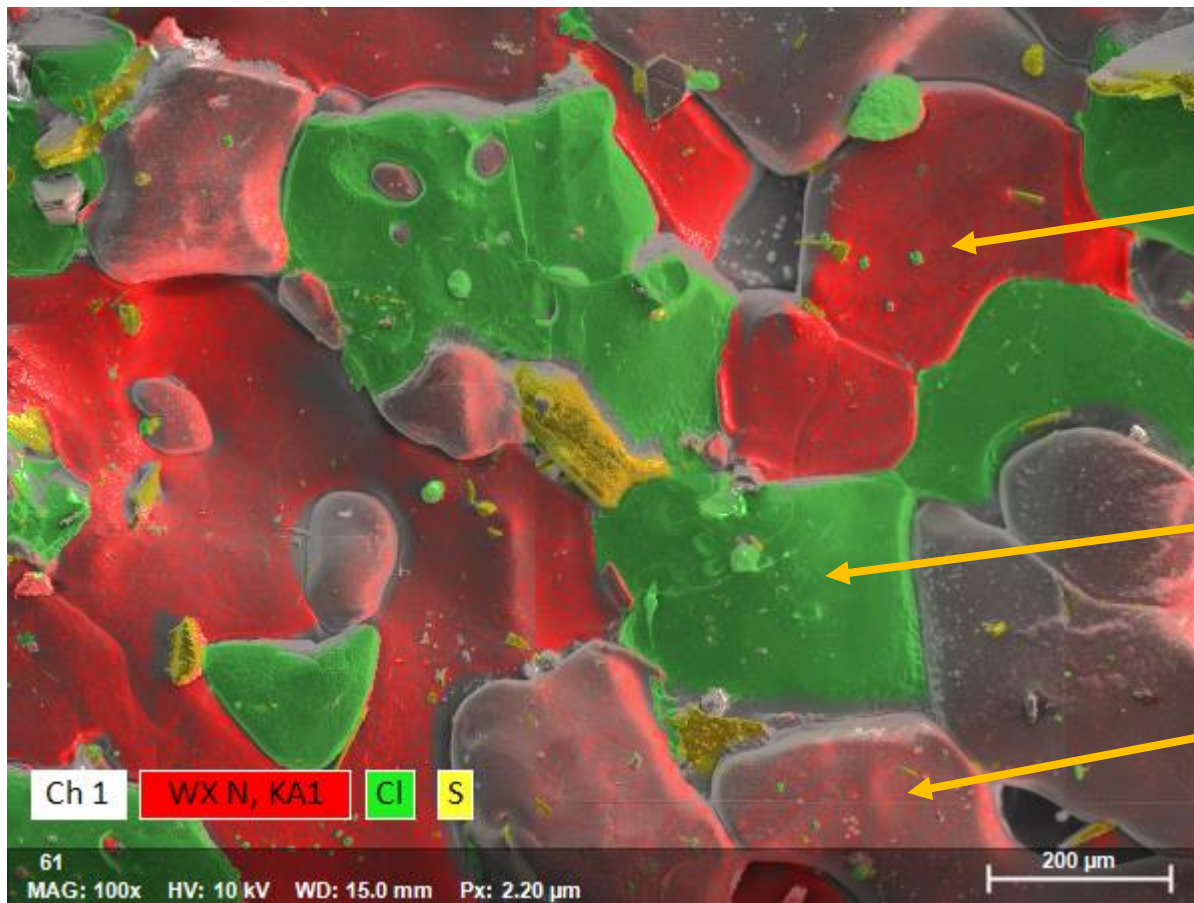


Sample: A. Menzies

600 x 450 px / 1.3 x 1 mm, 18 min

Nitrogen in minerals

- Combined WDS – EDS mapping of caliche ore from Atacama, Chile

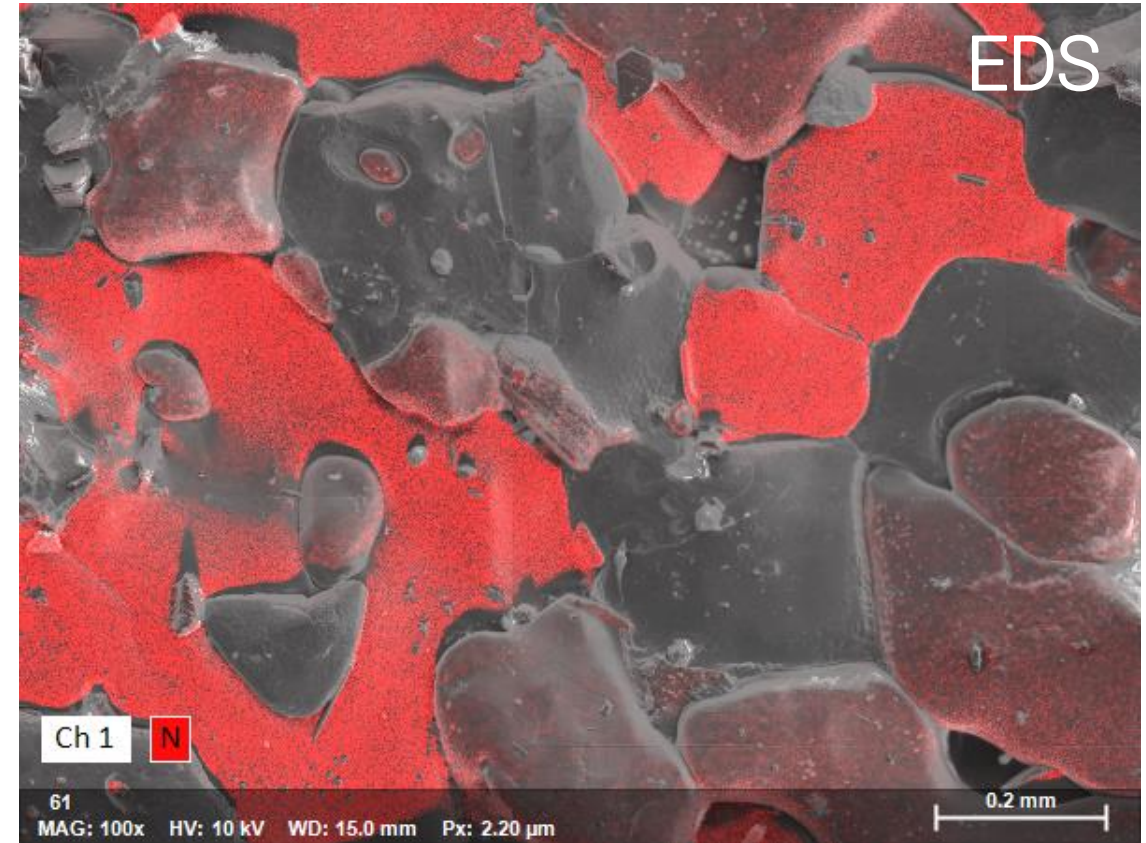
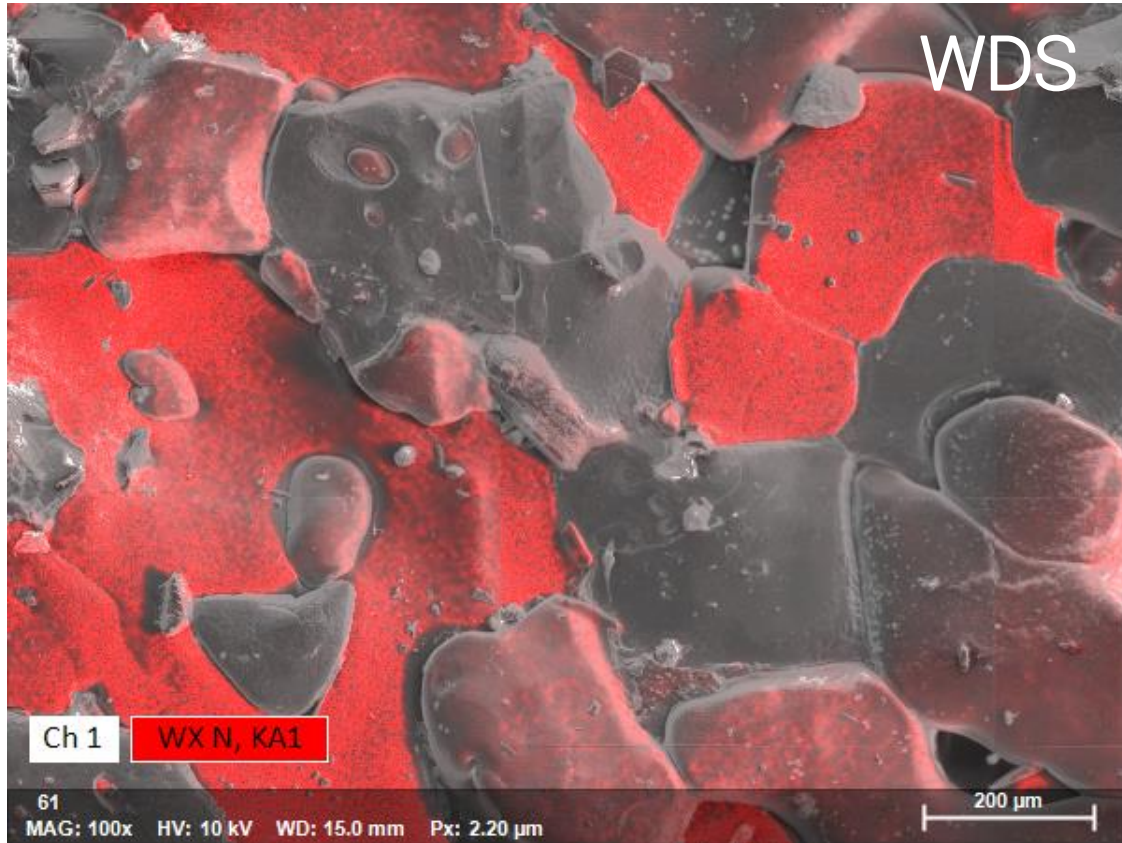


Sample: A. Menzies

600 x 450 px / 1.3 x 1 mm, 18 min

Nitrogen in minerals

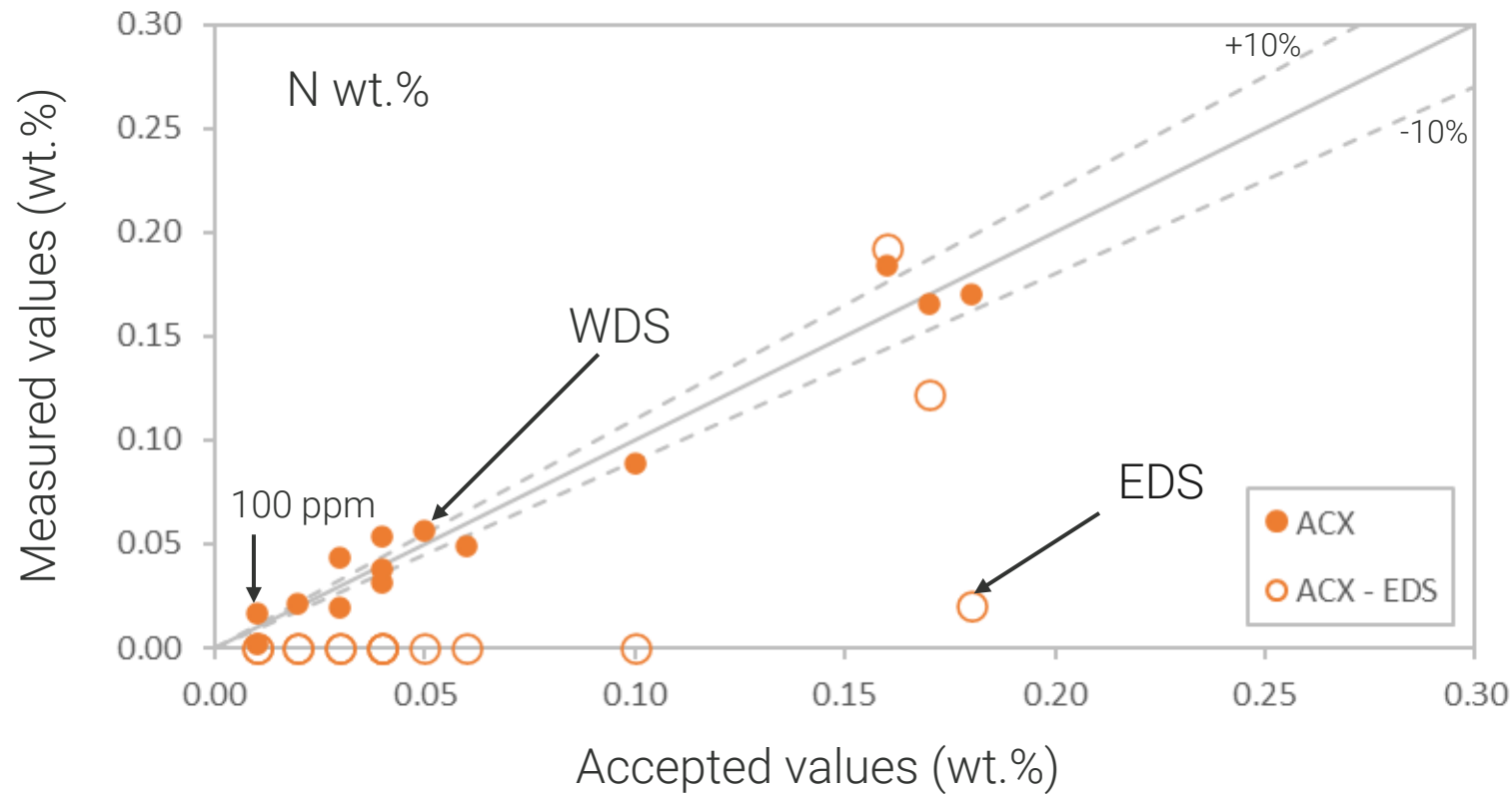
- WDS and EDS acquire X-rays simultaneously



➔ No large differences for major elements – WDS advantages for peak overlaps and trace elements

Nitrogen in steel

- Trace element quantification on certified reference steel samples



Samples:

15 certified steels (Acerinox) with nitrogen 100 – 1800 ppm

Parameter:

5kV, 10nA, 60s on peak

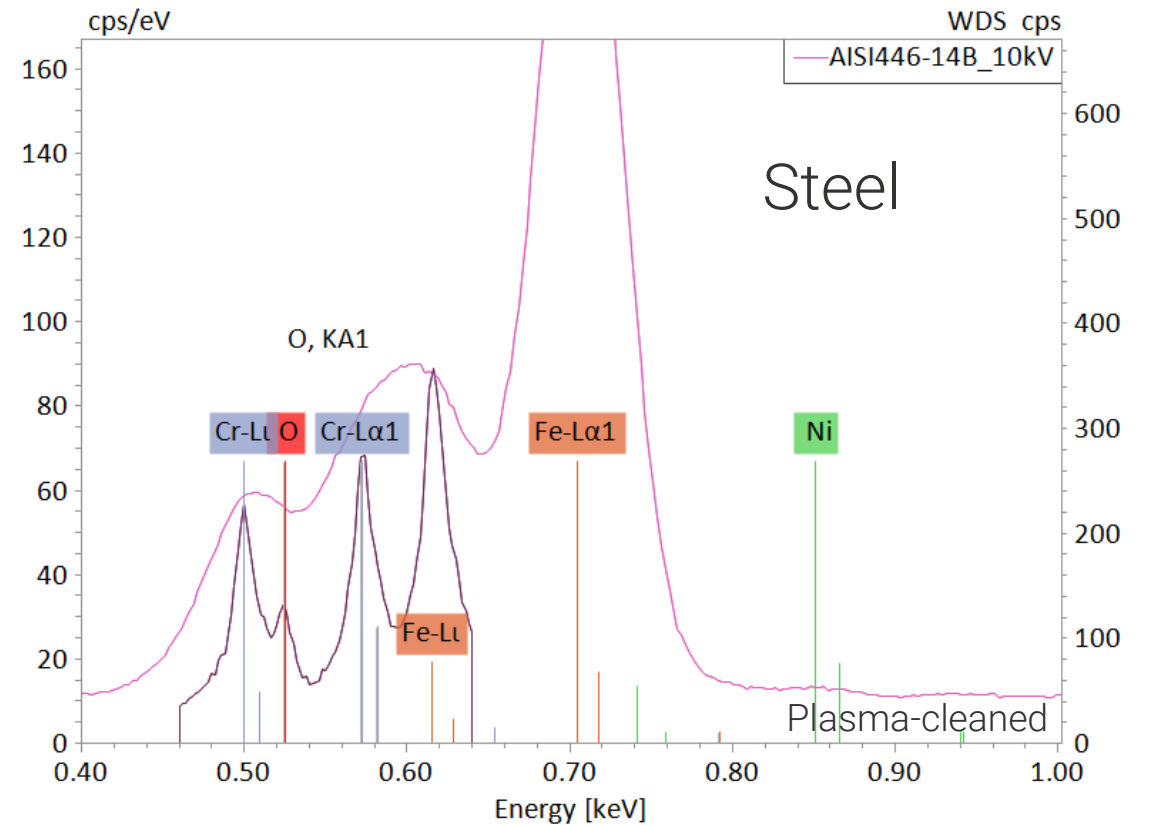
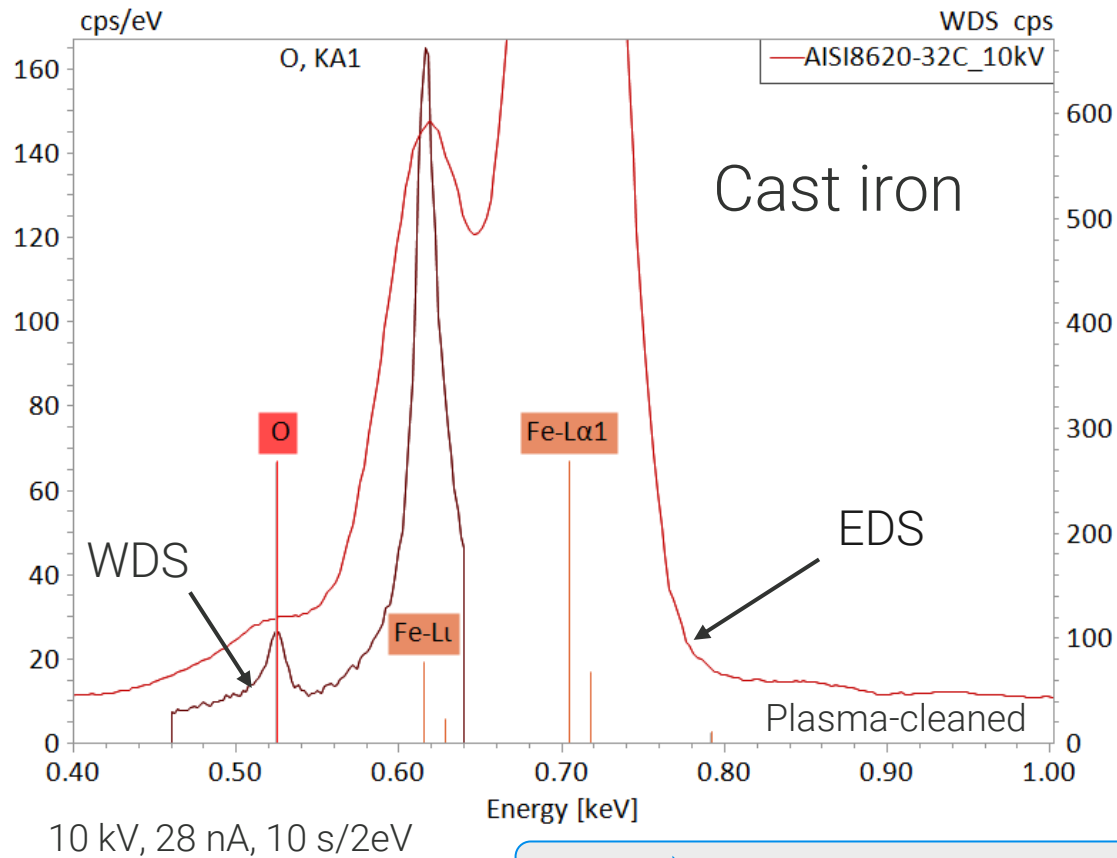
➡ WDS has lower limit of detection (LOD) than EDS

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Oxygen

Oxygen in cast iron and stainless steel

- Scan for O-K α in samples with and without Cr



➔ WDS resolves peak overlap of O-K α and Cr-L lines

QUANTAX WDS – LIGHT ELEMENT APPLICATIONS

Concluding remarks

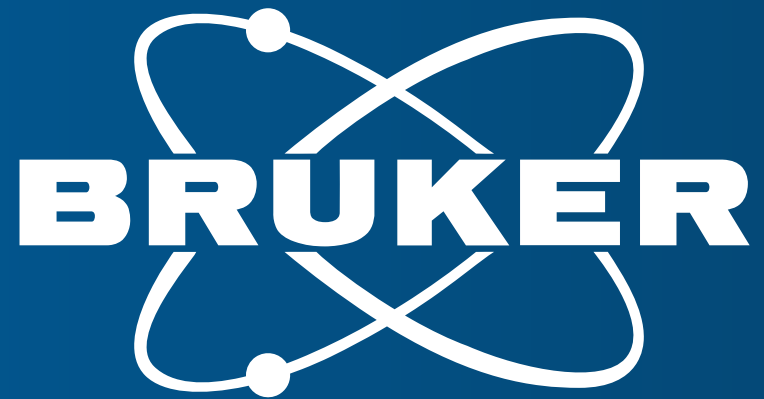
Advantages of QUANTAX WDS

- Designed for low X-ray energies
- High solid angle with state-of-the-art mirror optic
- High sensitivity for the light elements
- High count rates also with low beam currents
- High peak to background ratios
- High spectral resolution



PLEASE TYPE IN THE QUESTIONS YOU MIGHT HAVE IN THE Q&A BOX AND PRESS *SEND*.

Any questions?



Innovation with Integrity